NTEK 北测

EMC TEST REPORT

ETSI EN 301 489-1 V2.2.3 (2019-11) ETSI EN 301 489-3 V2.1.1 (2019-03) ETSI EN 301 489-17 V3.2.4 (2020-09) ETSI EN 301 489-19 V2.1.1 (2019-04) ETSI EN 301 489-52 V1.2.1 (2021-11) EN 55032:2015+A1:2020 EN 55035:2017+A11:2020 EN IEC 61000-3-2:2019+A1:2021 EN 61000-3-3:2013+A2:2021

> Product : Smart phone Trade Mark : Blackview Model Name : A53 Pro Family Model : N/A Report No. : STR221215001011E

Prepared for

DOKE COMMUNICATION (HK) LIMITED

RM 1902 EASEY COMM BLDG 253-261 HENNESSY ROAD WANCHAI HK CHINA

Prepared by

Shenzhen NTEK Testing Technology Co., Ltd.

 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street Bao'an District, Shenzhen 518126 P.R. China
 Tel. 400-800-6106, 0755-2320 0050, 0755-2320 0090 Website: http://www.ntek.org.cn

NTEK 北测

TEST RESULT CERTIFICATION

Applicant's Name:	DOKE COMMUNICATION (HK) LIMITED
Address:	RM 1902 EASEY COMM BLDG 253-261 HENNESSY ROAD WANCHAI HK CHINA
Manufacturer's Name:	Shenzhen DOKE Electronic Co.,Ltd
Address	801, Building3, 7th Industrial Zone, Yulv Community, Yutang Road, Guangming District, Shenzhen, China
Product description	
Product name:	Smart phone
Trade Mark:	Blackview
Model Name:	A53 Pro
Family Model:	N/A
	ETSI EN 301 489-1 V2.2.3 (2019-11)
	ETSI EN 301 489-3 V2.1.1 (2019-03)
	ETSI EN 301 489-17 V3.2.4 (2020-09)
Standards:	ETSI EN 301 489-19 V2.1.1 (2019-04)
	ETSI EN 301 489-52 V1.2.1 (2021-11)
	EN 55032:2015+A1:2020; EN 55035:2017+A11:2020
	EN IEC 61000-3-2:2019+A1:2021;EN 61000-3-3:2013+A2:2021

This device described above has been tested by NTEK, and the test results show that the equipment under test (EUT) is in compliance with the of article 3.1(b) of the Directive 2014/53/EU requirements. And it is applicable only to the tested sample identified in the report. This report shall not be reproduced except in full, without the written approval of NTEK, this document may be altered or revised by NTEK, personnel only, and shall be noted in the revision of the document.

Test Sample Number: T221215001R003

Date of Test

Date (s) of performance of tests..... : Dec 15, 2022 ~ Jan 03, 2023

Date of Issue...... Jan 03, 2023

Test Result Pass

Testing Engineer

Allen. Huang (Allen Huang)

Authorized Signatory:

(Alex Li)

Page 3 of 74 ____ Report No.: STR221215001011E

NTEK 北测[®]

			1
	Table of Contents	Page	
	1. TEST SUMMARY 1.1 TEST FACILITY 1.2 MEASUREMENT UNCERTAINTY	5 7 7	A.
	2 . GENERAL INFORMATION 2.1 GENERAL DESCRIPTION OF EUT 2.2 DESCRIPTION OF TEST MODES 2.3 DESCRIPTION OF TEST SETUP	9 9 11 13	
10	2.4 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL 2.5 MEASUREMENT INSTRUMENTS LIST	14 15	-
	 3. EMC EMISSION TEST 3.1 CONDUCTED EMISSION MEASUREMENT 3.1.1 POWER LINE CONDUCTED EMISSION 3.1.2 TELECOMMUNICATION PORT CONDUCTED EMISSION(VOLTAGE 3.1.3 TEST PROCEDURE 3.1.4 TEST SETUP 3.1.5 EUT OPERATING CONDITIONS 3.1.6 TEST RESULTS 	19 19 19 LIMITS) 22 22 22 22 23	20
	3.2 RADIATED EMISSION MEASUREMENT 3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT 3.2.2 LIMITS OF RADIATED EMISSION MEASUREMENT 3.2.3 TEST PROCEDURE 3.2.4 TEST SETUP 3.2.5 EUT OPERATING CONDITIONS 3.2.6 TEST RESULTS (30-1000MHz) 3.2.7 TEST RESULTS(1000-6000MHz)	25 25 26 27 27 28 29 31	NA No.
	3.3 HARMONICS CURRENT 3.3.1 LIMITS OF HARMONICS CURRENT 3.3.2 TEST PROCEDURE 3.3.3 EUT OPERATING CONDITIONS 3.3.4 TEST SETUP 3.3.5 TEST RESULTS	32 32 33 33 33 33 34	4
	 3.4 VOLTAGE FLUCTUATION AND FLICKERS 3.4.1 LIMITS OF VOLTAGE FLUCTUATION AND FLICKERS 3.4.2 TEST PROCEDURE 3.4.3 EUT OPERATING CONDITIONS 3.4.4 TEST SETUP 3.4.5 TEST RESULTS 	35 35 35 35 36 37	¥
			~

Page 4 of 74 Report No.: STR221215001011E

NTEK 北测

Table of Contents	Page
4. EMC IMMUNITY TEST	38
4.1 GENERAL PERFORMANCE CRITERIA 4.1.1 PERFORMANCE CRITERIA	38
4.2 GENERAL PERFORMANCE CRITERIA TEST SETUP	42
4.3 ESD TESTING	43
4.3.1 TEST SPECIFICATION	43
4.3.2 TEST PROCEDURE	43
4.3.3 TEST SETUP 4.3.4 TEST RESULTS	44 45
4.3.5 PHOTO(S) SHOWN THE LOCATION(S) OF ESD EVALUATED	48
4.4 RS TESTING	49
4.4.1 TEST SPECIFICATION	49
4.4.2 TEST PROCEDURE	49
4.4.3 TEST SETUP 4.4.4 TEST RESULTS	50 51
4.5 EFT/BURST TESTING	55
4.5.1 TEST SPECIFICATION	55
4.5.2 TEST PROCEDURE	55
4.5.3 TEST SETUP	56
4.5.4 TEST RESULTS	57
4.6 SURGE TESTING	59 59
4.6.2 TEST PROCEDURE	59
4.6.3 TEST SETUP	60
4.6.4 TEST RESULTS	61
4.7 INJECTION CURRENT TESTING	63
4.7.1 TEST SPECIFICATION	63
4.7.2 TEST PROCEDURE 4.7.3 TEST SETUP	63 63
4.7.4 TEST RESULTS	65
4.8 VOLTAGE INTERRUPTION/DIPS TESTING	68
4.8.1 TEST SPECIFICATION	68
4.8.2 TEST PROCEDURE	68
4.8.3 TEST SETUP 4.8.4 TEST RESULTS	68 69
5 . EUT TEST PHOTO	70

Page 5 of 74 ____ Report No.: STR221215001011E

1. TEST SUMMARY	,					
Test procedures acco ETSI EN 301 489-1 V		the technical standards:		1	A	
ETSI EN 301 489-3 V ETSI EN 301 489-17	/2.1.1 (2	2019-03)				
ETSI EN 301 489-19 ETSI EN 301 489-52 EN 55032:2015+A1:2	V2.1.1 V1.2.1 2020; El	(2019-04)				
		EMC Emission				
Standard		Test Item		Limit	Judgment	Remar
t stat	Cond	ucted Emission On AC And Te Port 150kHz to 30MHz	lecom	Class B	PASS	
		sturbance Voltage at The Anter Ferminals (30MHz To 2150MHz			N/A	¥
EN 55032:2015+A1: 2020	Wanted	d signal and disturbance voltag RF output terminals (30MHz To 2150MHz)	e at the		N/A	
	Ŷ	Radiated Emission 30MHz to 1000MHz		Class B	PASS	t.
AND A		Radiated Emission 1GHz to 6GHz	A.C.	Class B	PASS	
EN IEC 61000-3-2:2019+A1: 2021	Ţ	Harmonic Current Emission		Class A	N/A	NOTE (
EN 61000-3-3:2013+A2: 2021		Voltage Fluctuations & Flicker			PASS	
		EMC Immunity				-
Section EN 55035:2017+A11	1:2020	Test Item	Perforn Crite		Judgment	Remark
EN 61000-4-2:20	09	Electrostatic Discharge	В	1	PASS	
EN 61000-4-3:200 A1:2008+A2:20		RF electromagnetic field	A		PASS	
EN 61000-4-4:20)12	Fast transients	В		PASS	4
EN 61000-4-5:20 A1:2017	14+	Surges	В		PASS	4
EN 61000-4-6:20)14	Continuous radio frequency disturbances or Injected Current	А		PASS	ANCT OF
EN 61000-4-8:20	010	Power Frequency Magnetic Field	A	Ĵ	N/A	NOTE (3
EN 61000-4-11:20	004	Volt. Interruptions Volt. Dips	В / С NOTE		PASS	

Page 6 of 74 ____ Report No.: STR221215001011E

NOTE:

- (1)" N/A" denotes test is not applicable in this Test Report
- (2) Voltage dip: 100% reduction Performance Criteria B
 - Voltage dip: 30% reduction Performance Criteria C
 - Voltage Interruption: 100% Interruption Performance Criteria C

(3) Applicable only to equipment containing devices intrinsically susceptible to magnetic fields, such as CRT monitors, Hall effect elements, electro-dynamic microphones, magnetic field sensors or audio frequency transformers.

(4) For client's request and manual description, the test will not be executed.

Page 7 of 74 ____ Report No.: STR221215001011E

NTEK 北测[®]

1.1 TEST FACILITY

Shenzhen NTEK Testing Technology Co., Ltd. Add. : 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street Bao'an District, Shenzhen 518126 P.R. China

CNAS-Lab.	:	The Certificate Registration Number is L5516
IC-Registration	:	The Certificate Registration Number is CN0074
FCC- Accredited	:	Test Firm Registration Number: 463705 Designation Number: CN1184
A2LA-Lab.	:	The Certificate Registration Number is 4298.01 This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories.
		This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated 8 January 2009).

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $\mathbf{y} \pm \mathbf{U}$, where expended uncertainty \mathbf{U} is based on a standard uncertainty multiplied by a coverage factor of **k=2**, providing a level of confidence of approximately **95** %.

Test Item	Measurement Frequency Range	К	U(dB)
AC Mains Conducted Emission	0.009kHz ~ 0.15MHz	2	2.66
AC Mains Conducted Emission	0.15MH ~ 30MHz	2	2.80
Telecom Conducted Emission (Cat 3)	0.15MHz ~ 30MHz	2	2.40
Telecom Conducted Emission (Cat 5)	0.15MHz ~ 30MHz	2	2.58
Radiated Emission	30MHz ~ 1000MHz	2	2.64
Radiated Emission	1000MHz ~ 6000MHz	2	2.40
Radiated Emission	6000MHz ~ 18000MHz	2	2.52

Page 8 of 74 ____ Report No.: STR221215001011E

	REVISIO	n History	
Report No.	Version	Description	Issued Dat
STR221215001011E	Rev.01	Initial issue of report	Jan 03, 202
<u>,</u>		4	*
A St	4		
			7
		2° 7	
	5		
	Ť		
2			
1		4	
	5 .	× +	
			~
4	X		
L o		4	
		* 5 8	
¢.	+ 3		
× ×		4	~
Q 7	4		4
	5	Ċ.	
* *		- C	~
		Z	
			×
		2 1	
<u>s</u>			
		~	
	-		
~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~			
			+ +
, L K			

NTEK 北测

Page 9 of 74 ____ Report No.: STR221215001011E

2. GENERAL INFORMATION 2.1 GENERAL DESCRIPTION OF EUT Smart phone Equipment Trade Mark Blackview Model Name A53 Pro N/A Family Model N/A Model Difference **BT: 2402~2480 MHz** 2.4G WIFI: 802.11b/g/n(20MHz): 2412~2472MHz 802.11n(40MHz):2422~2462MHz ⊠5G WIFI:802.11a/ n(20/40)/ ac(20/40/80): 5180MHz~5240MHz;(20MHz) 5190MHz~5230MHz;(40MHz) 5210MHz;(80MHz) 5745-5825 MHz for 802.11a/n20/ac20; 5755-5795 MHz for 802.11n40/ac40; 5775MHz for 802.11 ac80; GSM/GPRS/EGPRS 900: 880~915MHz(TX) 925~960MHz (Rx) GSM/GPRS/EGPRS 1800: 1710~1785MHz(TX) 1805~1880MHz(Rx) WCDMA Band I: 1920 MHz ~1980 MHz(TX); 2110 MHz~2170 MHz(RX) WCDMA Band VIII: 880~915MHz(TX); 925~960MHz(RX) Frequency Bands: E-UTRA FDD Band I, III, VII, VIII, XX , XXVIII E-UTRA TDD XL FDD Band I: Uplink: 1920 MHz to 1980MHz Downlink: 2110 MHz to 2170 MHz FDD Band III: Uplink:1710 MHz to 1785 MHz Downlink: 1805 MHz to 1880 MHz FDD Band VII: Uplink: 2500 MHz to 2570 MHz Downlink: 2620 MHz to 2690 MHz FDD Band VIII: Uplink: 880MHz to 915 MHz Downlink: 925 MHz to 960 MHz FDD Band XX: Uplink: 832 MHz to 862 MHz Downlink: 791 MHz – 821 MHz FDD Band XXVIII: Uplink: 703 MHz to 748MHz Downlink: 758 MHz to 803 MHz TDD Band XL: Uplink & Downlink: 2300 MHz to 2400 MHz FM Receiver: 87.5 MHz to 108 MHz GPS: 1.57542GHz

Page 10 of 74 Report No.: STR221215001011E

Modulation Mode:	BT(1Mbps)/BLE: GFSK BT EDR(2Mbps): π/4-DQPSK BT EDR(3Mbps): 8-DPSK BLE(2Mbps): GFSK IEEE 802.11b : DSSS (CCK, DQPSK, DBPSK) IEEE 802.11g/n (HT20/HT40) : OFDM (64QAM, 16QAM, QPSK, BPSK) 802.11a:OFDM (BPSK / QPSK / 16QAM) 802.11n:OFDM (QPSK/BPSK/16QAM/64QAM) 802.11a:OFDM (QPSK/BPSK/16QAM/64QAM) S02.11a:OFDM (PSK/BPSK/16QAM/64QAM) S02.11a:OFDM (PSK/BPSK/16QAM/64QAM)
Adapter	Model: QZ-01000EA00 Input: 100-240V~50/60Hz 0.3A Output: 5.0V2.0A (10.0W)
Battery	DC 3.87V, 5080mAh, 19.66Wh
Rating	DC 3.87V from battery or DC 5V from adapter
Connecting I/O Port(s)	Please refer to the User's Manual
Antenna:	BT/WIFI/GPS: PIFA Antenna; GSM/WCDMA/LTE: PIFA Antenna; FM: Use earphone as Antenna;
Hard Ware Version	HCT-M659MB-A2
Soft Ware Version	A53Pro_EEA_M659_V1.0

Page 11 of 74 Report No.: STR221215001011E

NTEK 北测[®]

2.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	Charging + REC(Rear / Front)
Mode 2	Charging + TF Playing
Mode 3	Data transmission
Mode 4	Charging + FM(87.6MHz / 98MHz / 107.9MHz)
Mode 5	BT Link mode
Mode 6	Wi-Fi 2.4G/ Wi-Fi 5.2G/ Wi-Fi 5.8G
Mode 7	GSM / GPRS / EGPRS 900 / 1800
Mode 8	WCDMA / HSDPA / HSUPA B1 / B8
Mode 9	LTE Band 1 / 3 / 7 / 8 / 20 / 28 / 40
Mode 10	GPS Receiver

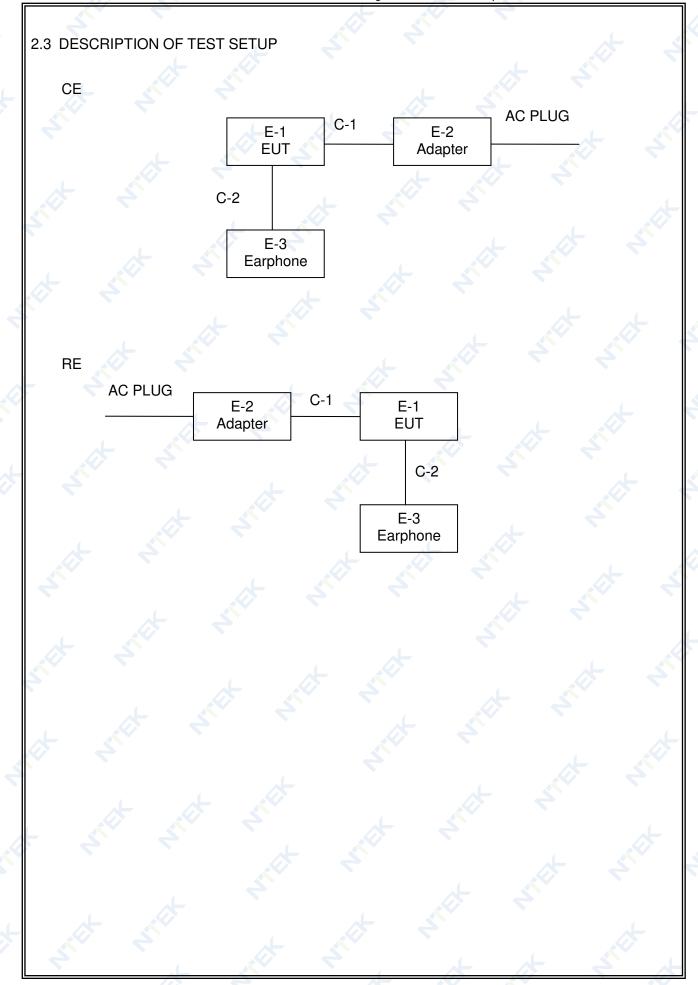
	For Conducted Test
Final Test Mode	Description
Mode 2	Charging + TF Playing

For Radiated Test				
Final Test Mode	Description			
Mode 2	Charging + TF Playing			
A A				
	For EMS Test			
Pretest Mode	Description			
Mode 1	Charging + REC(Rear / Front)			
Mode 2	Charging + TF Playing			
Mode 3	Data transmission			
Mode 4	Charging + FM(87.6MHz / 98MHz / 107.9MHz)			
Mode 5	BT Link mode			
Mode 6	Wi-Fi 2.4G/ Wi-Fi 5.2G/ Wi-Fi 5.8G			
Mode 7	GSM / GPRS / EGPRS 900 / 1800			
Mode 8	WCDMA / HSDPA / HSUPA B1 / B8			
Mode 9	LTE Band 1 / 3 / 7 / 8 / 20 / 28 / 40			
Mode 10	GPS Receiver			

NOTE: The test modes were carried out for all operation modes. The final test mode of the EUT was the worst test mode for EMI, and its test data was showed.



Page 13 of 74 Report No.: STR221215001011E



2.4 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Model/Type No.	Series No.	Note
E-1	Smart phone	A53 Pro	N/A	EUT
E-2	Adapter	QZ-01000EA00	<a>► N/A	Peripherals
E-3	Earphone	N/A	N/A	Peripherals
			×	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
	1	t		

			•		
ltem	Cable Type	Shielded Type	Ferrite Core	Length	Note
C-1	USB Cable	NO	NO	🤍 1.0m 🤝	4
C-1	Earphone Cable	NO	NO S	1.2m	
			4		

Note:

(1) (2)

- The support equipment was authorized by Declaration of Confirmation.
- For detachable type I/O cable should be specified the length in cm in [Length] column.

Page 15 of 74 Report No.: STR221215001011E

2.5 MEASUREMENT INSTRUMENTS LIST

2.5.1CONDUCTED EMISSION

lt	em	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
	1	Test Cable	N/A	C01	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
	2	Test Cable	N/A	C02	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
	3	Test Cable	N/A	C03	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
	4	Pulse Limiter	SCHWARZBE CK	VTSD 9561F	9716	Apr .06, 2022	Apr .05, 2023	1 year
	5	50Ω Switch	ANRITSU CORP	MP59B	620098370 4	May. 11, 2021	May. 10, 2024	3 year
	6	EMI Test Receiver	R&S	ESCI	101160	Apr .06, 2022	Apr .05, 2023	1 year
	7	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Apr .06, 2022	Apr .05, 2023	1 year
	8	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Apr .06, 2022	Apr .05, 2023	1 year
	9	LISN	SCHWARZBE CK	NNLK 8129	8129245	Apr .06, 2022	Apr .05, 2023	1 year
	10		R&S	ENV216	101313	Apr .06, 2022	Apr .05, 2023	1 year
0 5	2	RADIATED TES		* *		*		
	5.2	RAIJAIEIJIE:						
		Kind of		- N				Calibration
	em	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration		Calibration period
lt	em 1	Kind of Equipment Antenna Mast		SC100_1	N/A	N/A	N/A	period N/A
lt	em	Kind of Equipment Antenna Mast Turn Table	Manufacturer					period
It	em 1	Kind of Equipment Antenna Mast	Manufacturer EM	SC100_1	N/A	N/A	N/A	period N/A
It	em 1 2	Kind of Equipment Antenna Mast Turn Table EMI Test	Manufacturer EM EM	SC100_1 SC100	N/A 060531 101318 620098370 5	N/A N/A	N/A N/A	period N/A N/A
It	em 1 2 3	Kind of Equipment Antenna Mast Turn Table EMI Test Receiver 50Ω Switch Spectrum Analyzer	Manufacturer EM EM R&S	SC100_1 SC100 ESCI-7	N/A 060531 101318 620098370	N/A N/A Apr .06, 2022	N/A N/A Apr .05, 2023	period N/A N/A 1 year
It	em 1 2 3 4	Kind of Equipment Antenna Mast Turn Table EMI Test Receiver 50Ω Switch Spectrum Analyzer Unversal radio communication tester	Manufacturer EM EM R&S Anritsu Corp	SC100_1 SC100 ESCI-7 MP59B	N/A 060531 101318 620098370 5 MY451080	N/A N/A Apr .06, 2022 May. 11, 2021	N/A N/A Apr .05, 2023 May. 10, 2024	period N/A N/A 1 year 3 year
It	em 1 2 3 4 5	Kind of Equipment Antenna Mast Turn Table EMI Test Receiver 50Ω Switch Spectrum Analyzer Unversal radio communication	Manufacturer EM EM R&S Anritsu Corp Aglient	SC100_1 SC100 ESCI-7 MP59B E4407B	N/A 060531 101318 620098370 5 MY451080 40 1100.008.0	N/A N/A Apr .06, 2022 May. 11, 2021 Apr .01, 2022	N/A N/A Apr .05, 2023 May. 10, 2024 Mar .31 2023	period N/A N/A 1 year 3 year 1 year
It	em 1 2 3 4 5 6	Kind of EquipmentAntenna MastTurn TableEMI Test Receiver50Ω SwitchSpectrum AnalyzerUnversal radio communication testerWideband Radio Communication Tester	Manufacturer EM EM R&S Anritsu Corp Aglient R&S	SC100_1 SC100 ESCI-7 MP59B E4407B CMU200	N/A 060531 101318 620098370 5 MY451080 40 1100.008.0 2	N/A N/A Apr .06, 2022 May. 11, 2021 Apr .01, 2022 Jun.16, 2022	N/A N/A Apr .05, 2023 May. 10, 2024 Mar .31 2023 Jun.15, 2023	period N/A N/A 1 year 3 year 1 year 1 year
	em 1 2 3 4 5 6 7	Kind of EquipmentAntenna MastTurn TableEMI Test Receiver50Ω SwitchSpectrum AnalyzerUnversal radio communication testerWideband RadioCommunication TesterSpecifications	Manufacturer EM EM R&S Anritsu Corp Aglient R&S R&S	SC100_1 SC100 ESCI-7 MP59B E4407B CMU200 CMW500	N/A 060531 101318 620098370 5 MY451080 40 1100.008.0 2 148500	N/A N/A Apr .06, 2022 May. 11, 2021 Apr .01, 2022 Jun.16, 2022 Jun.16, 2022	N/A N/A Apr .05, 2023 May. 10, 2024 Mar .31 2023 Jun.15, 2023 Jun.15, 2023	period N/A N/A 1 year 3 year 1 year 1 year 1 year
	em 1 2 3 4 5 6 7 8	Kind of EquipmentAntenna MastTurn TableEMI Test Receiver50Ω SwitchSpectrum AnalyzerUnversal radio communication testerWideband RadioCommunication Tester SpecificationsTest Cable	Manufacturer EM EM R&S Anritsu Corp Aglient R&S R&S N/A	SC100_1 SC100 ESCI-7 MP59B E4407B CMU200 CMW500 R-01	N/A 060531 101318 620098370 5 MY451080 40 1100.008.0 2 148500 N/A	N/A N/A Apr .06, 2022 May. 11, 2021 Apr .01, 2022 Jun.16, 2022 Jun.16, 2022 Jun. 17, 2022	N/A N/A Apr .05, 2023 May. 10, 2024 Mar .31 2023 Jun.15, 2023 Jun.15, 2023 Jun. 16, 2025	period N/A N/A 1 year 3 year 1 year 1 year 1 year 3 years
	em 1 2 3 4 5 6 7 7 8 9	Kind of EquipmentAntenna MastTurn TableEMI Test Receiver50Ω SwitchSpectrum AnalyzerUnversal radio communication testerWideband RadioCommunication Tester SpecificationsTest CableTest Cable	Manufacturer EM EM R&S Anritsu Corp Aglient R&S R&S N/A	SC100_1 SC100 ESCI-7 MP59B E4407B CMU200 CMW500 R-01 R-01 R-02	N/A 060531 101318 620098370 5 MY451080 40 1100.008.0 2 148500 N/A N/A	N/A N/A Apr .06, 2022 May. 11, 2021 Apr .01, 2022 Jun.16, 2022 Jun.16, 2022 Jun. 17, 2022 Jun. 17, 2022	N/A N/A Apr .05, 2023 May. 10, 2024 Mar .31 2023 Jun.15, 2023 Jun.15, 2023 Jun. 16, 2025 Jun. 16, 2025	period N/A N/A 1 year 3 year 1 year 1 year 1 year 3 years 3 years

Page 16 of 74 Report No.: STR221215001011E

.5.3	HARMONICS A Kind of						Calibratio
Item	Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	period
1	Harmonic & Flicker	EM TEST	DPA500	0303-04	Apr .06, 2022	Apr .05, 2023	1 year
2	AC Power Source	EM TEST	ACS500	0203-01	Apr .06, 2022	Apr .05, 2023	1 year
3	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun. 16, 2022	Jun. 15, 2023	1 year
4	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun. 16, 2022	Jun. 15, 2023	1 year
.5.4	ESD						
Item	Kind of	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibratio period
1	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun. 16, 2022	Jun. 15, 2023	1 year
2	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun. 16, 2022	Jun. 15, 2023	1 year
3	Electrostatic Discharge Generator	Lioncel	ESD-203B	ESD203B0 150402	Jun. 16, 2022	Jun. 15, 2023	1 year
.5.5	BS	~ ~		·		¥)	
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibratic
							period
1	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun. 16, 2022	Jun. 15, 2023	period 1 year
1	Unversal radio communication	R&S	CMU200 CMW500		Jun. 16, 2022 Jun. 16, 2022	Jun. 15, 2023 Jun. 15, 2023	
<u>م</u>	Unversal radio communication tester Wideband Radio Communication Tester	7		2			1 year
2	Unversal radio communication tester Wideband Radio Communication Tester Specifications Audio Power	R&S	CMW500	2	Jun. 16, 2022	Jun. 15, 2023	1 year 1 year
2	Unversal radio communication tester Wideband Radio Communication Tester Specifications Audio Power Amplifier Mouth	R&S Brüel & Kjær	CMW500 4602B	2 148500 2185667	Jun. 16, 2022 Apr .06, 2022	Jun. 15, 2023 Apr .05, 2023	1 year 1 year 1 year
2 3 4	Unversal radio communication tester Wideband Radio Communication Tester Specifications Audio Power Amplifier Mouth Simulator Sound	R&S Brüel & Kjær Brüel & Kjær	CMW500 4602B 2669	2 148500 2185667 2143265	Jun. 16, 2022 Apr .06, 2022 Apr .06, 2022	Jun. 15, 2023 Apr .05, 2023 Apr .05, 2023	1 year 1 year 1 year 1 year 1 year
2 3 4 5	Unversal radio communication tester Wideband Radio Communication Tester Specifications Audio Power Amplifier Mouth Simulator Sound Calibrator 1/2" Pressure- field	R&S Brüel & Kjær Brüel & Kjær Brüel & Kjær	CMW500 4602B 2669 4185	2 148500 2185667 2143265 2194825	Jun. 16, 2022 Apr .06, 2022 Apr .06, 2022 Apr .06, 2022	Jun. 15, 2023 Apr .05, 2023 Apr .05, 2023 Apr .05, 2023	1 year 1 year 1 year 1 year 1 year

Page 17 of 74 Report No.: STR221215001011E

9	Ear Simulator for Telephonometr y	Brüel & Kjær	4185	2553612	Apr .06, 2022	Apr .05, 2023	1 year
10	Bilog Antenna	ETS	3142E(Fequ ency range 30MHz to 6 GHz)	00214344	Mar. 30, 2022	Jun. 29, 2023	1 year
11	Broadband Amplifier	AR	60S1G6	0350414	Jun. 26, 2022	Jun. 25, 2023	1 year
12	MXG Vector Signal Generator	Agilent	N5182A	MY470703 17	Jun. 16, 2022	Jun. 15, 2023	1 year
13	Power Amplifier	rflight	NTWPA-00 810200	17063153	Jun. 17, 2022	Jun. 16, 2023	1 year
14	Power Amplifier	AR	25S1G4A	308598	Jun. 17, 2022	Jun. 16, 2023	1 year
15	Power Meter	Agilent	E4419B	MY451025 38	Jun. 17, 2022	Jun. 16, 2023	1 year
16	Power Sensor	Agilent	E9301A	MY414956 44	Jun. 17, 2022	Jun. 16, 2023	1 year
17	Power Sensor	Agilent	E9301A	US392121 48	Jun. 17, 2022	Jun. 16, 2023	1 year

2.5.6 SURGE, EFT/BURST, VOLTAGE INTERRUPTION/DIPS

_								
	ltem	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
	1	Surge Generator	EVERFINE	EMS61000- 5A-V1	1101002	Apr .06, 2022	Apr .05, 2023	1 year
	2	DIPS Generator 🏑	EVERFINE	EMS61000- 11K	1011002	Apr .06, 2022	Apr .05, 2023	1 year
	3	EFT/B Generator	EVERFINE	EMS61000- 4A-V2	1012005	Apr .06, 2022	Apr .05, 2023	1 year
	4	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun. 16, 2022	Jun. 15, 2023	1 year
	4	Wideband Radio		CMMEDO	149500	lup 16 2022	lup 15 0000	1 voor
	5	Communication Tester Specifications	R&S	CMW500	148500	Jun. 16, 2022	Jun. 15, 2023	1 year

2.5.7 INJECTION CURRENT

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
Attenuator	TESEQ	ATN 6075	38411	N/A	N/A	N/A
RF Cable	TESEQ	RF Cable	N/A	N/A	N/A	N/A
Signal Generator	R&S	SML03	100954	Nov. 01, 2022	Oct. 31, 2023	1 year
Power Amplifier	TESEQ	CBA 230M-080	T44376	Jun. 16, 2022	Jun. 15, 2023	1 year
EM Clamp	FCC	F-203I-23M M	504	Apr .06, 2022	Apr .05, 2023	1 year
Audio Power Amplifier	Brüel & Kjær	4602B	2185667	Apr .06, 2022	Apr .05, 2023	1 year
	Equipment Attenuator RF Cable Signal Generator Power Amplifier EM Clamp Audio Power	EquipmentManufacturerAttenuatorTESEQRF CableTESEQSignal GeneratorR&SPower AmplifierTESEQEM ClampFCCAudio PowerBrüel & Kiær	EquipmentManufacturerType No.AttenuatorTESEQATN 6075RF CableTESEQRF CableSignal GeneratorR&SSML03Power AmplifierTESEQCBA 230M-080EM ClampFCCF-203I-23M MAudio PowerBrüel & Kiær4602B	EquipmentManufacturerType No.Serial No.AttenuatorTESEQATN 607538411RF CableTESEQRF CableN/ASignal GeneratorR&SSML03100954Power AmplifierTESEQCBA 230M-080T44376EM ClampFCCF-203I-23M M504Audio PowerBrüel & Kiær4602B2185667	EquipmentManufacturerType No.Serial No.Last calibrationAttenuatorTESEQATN 607538411N/ARF CableTESEQRF CableN/AN/ASignal GeneratorR&SSML03100954Nov. 01, 2022Power AmplifierTESEQCBA 230M-080T44376Jun. 16, 2022EM ClampFCCF-203I-23M M504Apr .06, 2022Audio PowerBrüel & Kiær4602B2185667Apr .06, 2022	EquipmentManufacturerType No.Serial No.Last calibrationCalibrated untilAttenuatorTESEQATN 607538411N/AN/ARF CableTESEQRF CableN/AN/AN/ASignal GeneratorR&SSML03100954Nov. 01, 2022Oct. 31, 2023Power AmplifierTESEQCBA 230M-080T44376Jun. 16, 2022Jun. 15, 2023EM ClampFCCF-203I-23M M504Apr .06, 2022Apr .05, 2023Audio PowerBrüel & Kizer4602B2185667Apr .06, 2022Apr .05, 2023

Page 18 of 74 Report No.: STR221215001011E

7	Mouth Simulator	Brüel & Kjær	2669	2143265	Apr .06, 2022	Apr .05, 2023	1 year
8	Sound Calibrator	Brüel & Kjær	4185	2194825	Apr .06, 2022	Apr .05, 2023	1 year
9	1/2" Pressure- field Microphone	Brüel & Kjær	735	2641678	Apr .06, 2022	Apr .05, 2023	1 year
10	Audio Analyzer	R&S	UPV	100419	Apr .06, 2022	Apr .05, 2023	1 year
11	Ear Simulator for Telephonometr y	Brüel & Kjær	4185	2553612	Apr .06, 2022	Apr .05, 2023	1 year
12	Telephone Test Head	Brüel & Kjær	4185	2631728	Apr .06, 2022	Apr .05, 2023	1 year
13	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun .16, 2022	Jun .15, 2023	1 year
14	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun .16, 2022	Jun .15, 2023	1 year
15	Coupling and Decoupling Network	TESEQ	CDN M016	38722	Apr .06, 2022	Apr .05, 2023	1 year

3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT 3.1.1 POWER LINE CONDUCTED EMISSION

(Frequency Range 150kHz-30MHz)

 Table A.8 – Requirements for conducted emissions from the AC mains power ports of Class A equipment

Applicabl	e to						
1. AC mains power ports (3.1.1)							
Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class A limits dB(μV)			
A8.1	0,15 - 0,5			79			
	0,5 – 30	AMN	Quasi Peak / 9 kHz —	73			
A8.2	0,15 - 0,5	AMN		66			
	0,5 - 30	Alvin	Average / 9 kHz	60			

Apply A8.1 and A8.2 across the entire frequency range.

Table A.9 – Requirements for conducted emissions from the AC mains power portsof Class B equipment

Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class B limits dB(µV)
A9.1	0,15 - 0,5			66 – 56
	0,5 – 5	AMN	Quasi Peak / 9 kHz	56
	5 – 30			60
A9.2	0,15 - 0,5			56 – 46
	0,5 – 5	AMN	Average / 9 kHz	46
	5 – 30			50

Apply A9.1 and A9.2 across the entire frequency range.

Note:

Applicable to

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

3.1.2 TELECOMMUNICATION PORT CONDUCTED EMISSION(VOLTAGE LIMITS)

(Frequency Range 150kHz-30MHz)

Table A.10 – Requirements for asymmetric mode conducted emissions from Class A equipment

Арр	licab	le to	
-----	-------	-------	--

wired network ports (3.1.30)
 optical fibre ports (3.1.24) with metallic shield or tension members
 antenna ports (3.1.3)

Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class A voltage limits dB(µV)	Class A current limits dB(µA)
A10.1	0,15 - 0,5		Oursei Darsh (O hille	97 – 87	
	0,5 – 30	AAN	Quasi Peak / 9 kHz	87	
	0,15 - 0,5			84 – 74	n/a
	0,5 - 30	AAN	Average / 9 kHz	74	
A10.2	0,15 – 0,5	CVP	Oursei Darsh (Olikila	97 – 87	53 – 43
	0,5 - 30	and current probe	Quasi Peak / 9 kHz	87	43
	0,15 - 0,5	CVP		84 – 74	40 – 30
	0,5 - 30	and current probe	Average / 9 kHz	74	30
A10.3	0,15 - 0,5	Current Probe	Quasi Peak / 9 kHz		53 – 43
	0,5 - 30	Current Probe	Quasi Feak / 9 KHZ		43
	0,15 – 0,5	Oursent Droke		n/a	40 – 30
	0,5 - 30	Current Probe	Average / 9 kHz		30

The choice of coupling device and measurement procedure is defined in Annex C.

AC mains ports that also have the function of a wired network port shall meet the limits given in Table A.8.

The test shall cover the entire frequency range.

The application of the voltage and/or current limits is dependent on the measurement procedure used. Refer to Table C.1 for applicability.

Testing is required at only one EUT supply voltage and frequency.

Applicable to ports listed above and intended to connect to cables longer than 3 m.

Page 21 of 74 Report No.: STR221215001011E

Table A.12 – Requirements for conducted differential voltage emissions from Class B equipment

Applicable to

1. TV broadcast receiver tuner ports (3.1.8) with an accessible connector

2. RF modulator output ports (3.1.27)

3.	FM broadca	st receiver	r tuner	ports	(3.1.8)	with	an	accessible	connector
----	------------	-------------	---------	-------	---------	------	----	------------	-----------

Table clause	Frequency range	Detector type/ bandwidth		Class B lim dB(µV) 75 :	Applicability	
	MHz		Other	Local Oscillator Fundamental	Local Oscillator Harmonics	-
A12.1	30 – 950		46	46	46	See a)
	950 – 2 150	For frequencies ≤1 GHz	46	54	54	
A12.2	950 – 2 150	Quasi Peak/	46	54	54	See b)
A12.3	30 – 300	120 kHz	46	54	50	See c)
	300 – 1 000				52	
A12.4	30 – 300	For frequencies	46	66	59	See d)
	300 – 1 000	≥1 GHz			52	
A12.5	30 – 950	Peak/ 1 MHz	46	76	46	See e)
	950 – 2 150	1 1/11/2		n/a	54	

a) Television receivers (analogue or digital), video recorders and PC TV broadcast receiver tuner cards working in channels between 30 MHz and 1 GHz, and digital audio receivers.

b) Tuner units (not the LNB) for satellite signal reception.

c) Frequency modulation audio receivers and PC tuner cards.

d) Frequency modulation car radios.

e) Applicable to EUTs with RF modulator output ports (for example DVD equipment, video recorders, camcorders and decoders etc.) designed to connect to TV broadcast receiver tuner ports.

Testing is required at only one EUT supply voltage and frequency.

The term 'other' refers to all emissions other than the fundamental and the harmonics of the local oscillator.

The test shall be performed with the device operating at each reception channel.

The test shall cover the entire frequency range.

The following table is the setting of the receiver

Setting
10 dB
0.15 MHz
30 MHz
9 kHz 💉 🔶

Page 22 of 74 Report No.: STR221215001011E

NTEK 北测

3.1.3 TEST PROCEDURE

- a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item -EUT Test Photos.

Vertical Reference Ground Plane EUT BOCM BOCM Horizontal Reference Ground Plane Horizontal Reference Ground Plane

Note: 1.Support units were connected to second LISN. 2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

3.1.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.2 Unless otherwise a special operating condition is specified in the follows during the testing.

3.1.4 TEST SETUP

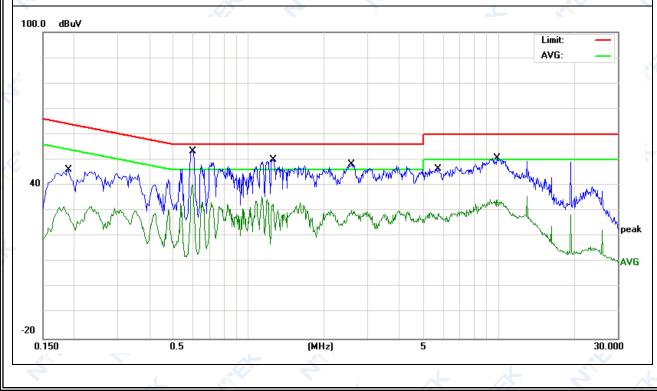
Page 23 of 74 Report No.: STR221215001011E

3.1.6 TEST RESULTS

EUT:	Smart phone		Model Nam	le:	A53 Pro		
Temperature:	24.7 ℃	4	Relative Hu	Relative Humidity: 53%			
Pressure:1010hPaTest Voltage:DC 5V from Adapter AC 230V/50Hz			Phase:				
			Test Mode:		Mode 2		
	<u> </u>		* 5	5	•		
Frequency	Meter Reading	Factor	Emission Level	Limits	s Margin	Domor	
(MHz)	(dBµV)	(dB)	(dBµV)	(dBµ∨	/) (dB)	Remark	
0.1900	36.63	9.61	46.24	64.03	3 -17.79	QP	
0.1900	18.76	9.61	28.37	54.03	3 -25.66	AVG	
0.5980	42.33	9.67	52.00	56.00	0 -4.00	QP	
0.5980	30.44	9.67	40.11	46.00) -5.89	AVG	
1.2579	40.47	9.68	50.15	56.00) -5.85	QP	
1.2579	22.93	9.68	32.61	46.00) -13.39	AVG	
2.5940	38.51	9.72	48.23	56.00) -7.77	QP	
2.5940	20.42	9.72	30.14	46.00) -15.86	AVG	
5.7140	36.73	9.80	46.53	60.00) -13.47	QP	
5.7140	18.93	9.80	28.73	50.00) -21.27	AVG	
9.9100	40.79	9.93	50.72	60.00) -9.28	QP	
9.9100	24.44	9.93	34.37	50.00) -15.63	AVG	

Remark:

All readings are Quasi-Peak and Average values.
 Factor = Insertion Loss + Cable Loss.

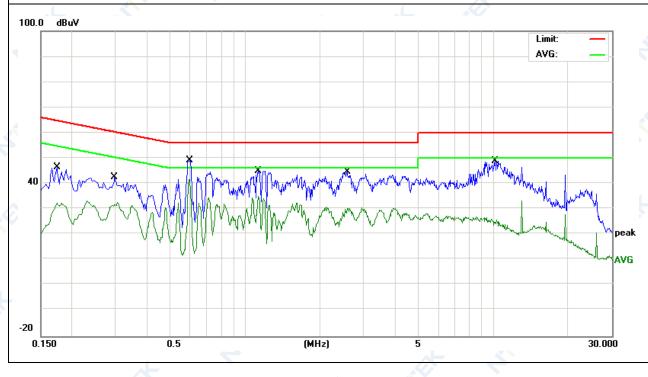


Report No.: STR221215001011E Page 24 of 74

<u> </u>	•							
EUT:	Smart phone		~	Model Nam	e:	A53	8 Pro	Y .
Temperature:	21.1℃		₩.	Relative Humidity:		50%		
Pressure:	1010hPa			Phase: N		N		
Test Voltage:	e: DC 5V from Adapter AC 230V/50Hz		¥	Test Mode:		Мос	de 2	
		× `					<u>k</u>	<u>k</u> 2
Frequency	Meter Reading	Factor	Emis	sion Level	Limit	s	Margin	Remark
(MHz)	(dBµV)	(dB)		(dBµV)	(dBµV)		(dB)	nemaik
0.1740	36.86	9.65		46.51	64.76	6	-18.25	QP
0.1740	22.37	9.65		32.02	54.76	6	-22.74	AVG
0.2980	32.77	9.64		42.41	60.30)	-17.89	QP
0.2980	22.08	9.64		31.72	50.30)	-18.58	AVG
0.5980	39.36	9.67		49.03	56.00)	-6.97	QP
0.5980	31.46	9.67		41.13	46.00)	-4.87	AVG
1.1300 🧷	35.24	9.68		44.92	56.00)	-11.08	QP
1.1300	25.43	9.68		35.11	46.00)	-10.89	AVG
2.5740	34.86	9.69		44.55	56.00)	-11.45	QP
2.5740	20.60	9.69		30.29	46.00)	-15.71	AVG
10.1340	39.01	9.90		48.91	60.00)	-11.09	QP
10.1340	14.90	9.90		24.80	50.00)	-25.20	AVG

Remark:

All readings are Quasi-Peak and Average values.
 Factor = Insertion Loss + Cable Loss.



Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.

Page 25 of 74 Report No.: STR221215001011E

3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT (Below 1000MHz)

Table A.2 – Requirements for radiated emissions at frequencies up to 1 GHz for Class A equipment

Table clause	Frequency range	Me	easurement	Class A limits dB(µV/m)
ciuuse	MHz	Distance m	Detector type/ bandwidth	OATS/SAC (see Table A.1)
A2.1	30 – 230	10		40
	230 – 1 000	10	Quasi Peak /	47
A2.2	30 – 230	<u>,</u>	120 kHz	50
	230 – 1 000	3		57

Apply only A2.1 or A2.2 across the entire frequency range.

Table A.4 – Requirements for radiated emissions at frequencies up to 1 GHz for Class B equipment

Table clause	Frequency range	Measurement		Class B limits dB(µV/m)
ciuuse	MHz	Distance m	Detector type/ bandwidth	OATS/SAC (see Table A.1)
A4.1	30 – 230	10		30
	230 – 1 000	10	Quasi Peak /	37
A4.2	30 – 230		120 kHz	40
	230 – 1 000	3		47

Apply only table clause A4.1 or A4.2 across the entire frequency range.

Table A.6 – Requirements for radiated emissions from FM receivers

Table	Frequency range	Ме	asurement	Class B lim	it dB(μV/m)
clause	MHz	Distance Detector type/		Fundamental	Harmonics
		m	bandwidth	OATS/SAC (see Table A.1)	OATS/SAC (see Table A.1)
A6.1	30 – 230				42
	230 - 300	10		50	42
	300 – 1 000		Quasi peak/		46
A6.2	30 – 230		120 kHz		52
	230 – 300	3		60	52
	300 – 1 000			56	

Apply only A.6.1 or A.6.2 across the entire frequency range.

These relaxed limits apply only to emissions at the fundamental and harmonic frequencies of the local oscillator. Signals at all other frequencies shall be compliant with the limits given in Table A.4.

NTEK 北测

3.2.2 LIMITS OF RADIATED EMISSION MEASUREMENT (Above 1000MHz)

Table A.3 – Requirements for radiated emissions at frequencies above 1 GHz for Class A equipment

Table clause	Frequency range	Me	easurement	Class A limits dB(µV/m)
Glube	MHz	Distance m	Detector type/ bandwidth	FSOATS (see Table A.1)
A3.1	1 000 – 3 000		Average /	56
	3 000 - 6 000	2	1 MHz	60
A3.2	1 000 – 3 000	3	Peak /	76
	3 000 - 6 000		1 MHz	80

Apply A3.1 and A3.2 across the frequency range from 1 000 MHz to the highest required frequency of measurement derived from Table 1.

Table A.5 – Requirements for radiated emissions at frequencies above 1 GHz for Class B equipment

Table clause	Frequency range Measurement		easurement	Class B limits dB(µV/m)
	MHz	Distance m	Detector type/ bandwidth	FSOATS (see Table A.1)
A5.1	1 000 – 3 000		Average/	50
	3 000 – 6 000	3	1 MHz	54
A5.2	1 000 – 3 000	5	Peak/	70
	3 000 – 6 000		1 MHz	74

Apply A5.1 and A5.2 across the frequency range from 1 000 MHz to the highest required frequency of measurement derived from Table 1.

Notes:

- (1) The limit for radiated test was performed according to as following: CISPR 32.
- (2) The tighter limit applies at the band edges.
- (3) Emission level ($dB\mu V/m$)=20log Emission level (uV/m).

Page 27 of 74 Report No.: STR221215001011E

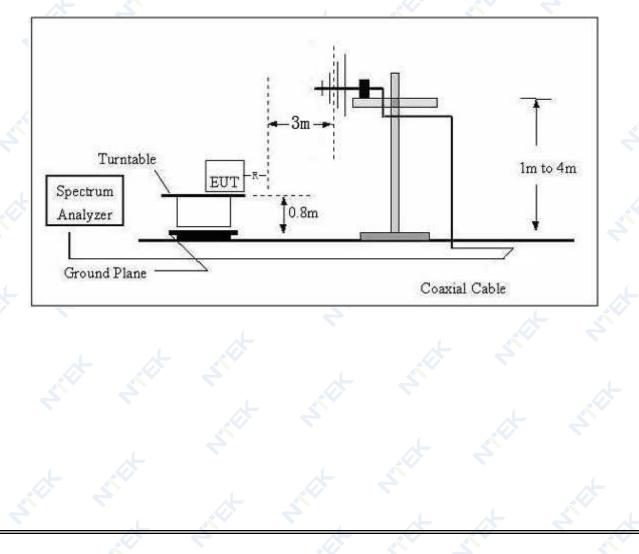
NTEK 北测

3.2.3 TEST PROCEDURE

- a. The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.
- f. For the actual test configuration, please refer to the related Item -EUT Test Photos.

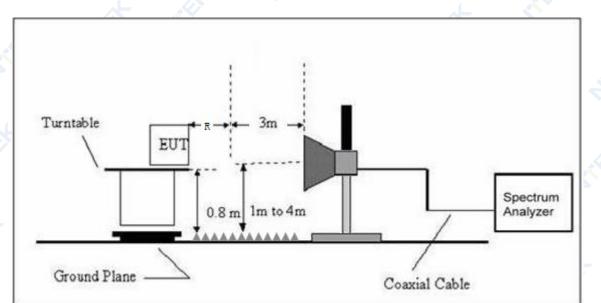
3.2.4 TEST SETUP

(A) Radiated Emission Test Set-Up Frequency Below 1 GHz



Page 28 of 74 Report No.: STR221215001011E

(B) Radiated Emission Test Set-Up Frequency Above 1GHz



3.2.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.2** Unless otherwise a special operating condition is specified in the follows during the testing.

3.2.6 TEST RESULTS (30-1000MHz)

	Smart phone			Model Nar	ne:	A53	Pro	
emperature:	23.9 ℃			Relative H	umidity:	52%		
ressure:	1010 hPa			Polarizatio	n:	Verti	cal 🔬	
est Power:	DC 5V from Adapter Test Mode: Mode 2 AC 230V/50Hz Test Mode: Mode 2		e 2 🔶					
		_			2			
Frequency	Meter Reading	Factor	>	sion Level	Limit		Margin	Remark
(MHz)	(dBµV)	(dB)		3µV/m)	(dBµV		(dB)	
32.1794	7.41	24.64	3	32.05	40.0	0	-7.95	QP
41.5670	10.46	19.58	3	30.04	40.0	0	-9.96	QP
183.2005	19.72	16.73	3	36.45	40.0	0	-3.55	QP
766.0570	7.36	28.95	3	36.31	47.0	0	-10.69	QP
893.8567	7.70	30.38	3	38.08	47.0	0	-8.92	QP
993.0113	6.40	31.66	3	38.06	47.0	0	-8.94	QP
72.0 dBuV/m							Limit: Margin:	
				3			Margin:	
	Many May May Market	1	www	3 X X				
32 1 2 -8								4 5 S 4 M - 2 M - 2 M - 2 M - 2 M - 2 M - 2 M -
	50 60 70 80		(MHz)			400	Margin:	4 5 S 4 M - 2 M - 2 M - 2 M - 2 M - 2 M - 2 M -

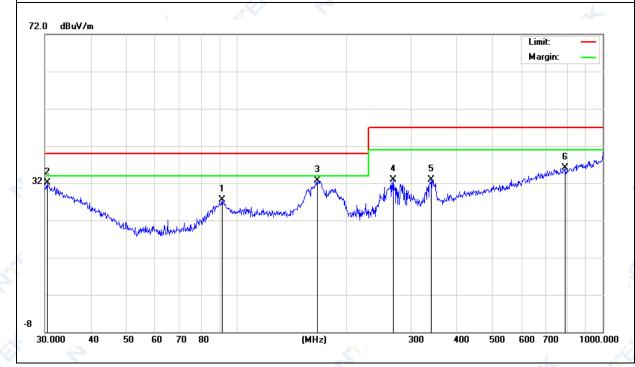
Page 30 of 74 Report No.: STR221215001011E

~			
EUT:	Smart phone 👔 🦲	Model Name:	A53 Pro
Temperature:	24.5℃	Relative Humidity:	51%
Pressure:	1010 hPa 🧼	Polarization:	Horizontal
Test Power:	DC 5V from Adapter AC 230V/50Hz	Test Mode:	Mode 2

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Domork
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Remark
91.4949	10.22	17.20	27.42	40.00	-12.58	QP
30.4238	6.32	25.87	32.19	40.00	-7.81	QP
166.0680	15.14	17.65	32.79	40.00	-7.21	QP
268.4853	13.46	19.46	32.92	47.00	-14.08	QP
339.5888	11.56	21.25	32.81	47.00	-14.19	QP
787.8513	6.78	29.33	36.11	47.00	-10.89	QP
					· •	

Remark:

1. Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit.



Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.

3.2.7 TEST RESULTS(1000-6000MHz)

EUT:	Smart phone	Model Name:	A53 Pro		
Temperature:	24.5 ℃	Relative Humidity:	51%		
Pressure:	1010 hPa	Test Mode:	Mode 2	. (
Test Power:	DC 5V from Adapter AC 230V/50Hz			2	

Polar	Frequency	Meter Reading (dBµV/m)	Factor (dB)	Emission Level	Limits	Margin (dB)	Remark
(H/V)	(MHz)			(dBµV/m)	(dBµV/m)		
V	2112.500	38.29	11.51	49.80	70.00	-20.20	peak
V	2112.500	27.63	11.51	39.14	50.00	-10.86	AVG
V	2700.000	38.10	11.59	49.69	70.00	-20.31	peak
V	2700.000	28.52	11.59	40.11	50.00	-9.89	AVG
V	3462.500	37.09	13.91	51.00	74.00	-23.00	peak
V	3462.500	27.69	13.91	41.60	54.00	-12.40	AVG
V	4262.500	37.73	17.86	55.59	74.00	-18.41	peak
V	4262.500	24.28	17.86	42.14	54.00	-11.86	AVG
V	4775.000	36.29	19.41	55.70	74.00	-18.30	peak
V	4775.000	23.48	19.41	42.89	54.00	-11.11	AVG
V	5900.000	35.19	19.38	54.57	74.00	-19.43	peak
V	5900.000	22.92	19.38	42.30	54.00	-11.70	AVG
Н	2200. <mark>000</mark>	38.28	10.95	49.23	70.00	-20.77	peak
Н	2200.000	28.52	10.95	39.47	50.00	-10.53	AVG
Н	2762.500	37.43	11.55	48.98	70.00	-21.02	peak
Н	2762.500	27.92	11.55	39.47	50.00	-10.53	AVG
Н	2962.500	37.01	11.69	48.70	70.00	-21.30	peak
Н	2962.500	26.61	11.69	38.30	50.00	-11.70	AVG
Н	4237.500	38.14	17.64	55.78	74.00	-18.22	peak
Н	4237.500	24.50	17.64	42.14	54.00	-11.86	AVG
Н	4925.000	36.40	19.32	55.72	74.00	-18.28	peak
Н	4925.000	23.82	19.32	43.14	54.00	-10.86	AVG
Н	5400.000	35.96	18.85	54.81	74.00	-19.19	peak
Н	5400.000	23.35	18.85	42.20	54.00	-11.80	AVG

Remark: Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit

Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.

Page 32 of 74 Report No.: STR221215001011E

3.3 HARMONICS CURRENT

3.3.1LIMITS OF HARMONICS CURRENT

Table 1 – Limits for Class A equipment

Harmonic order (n)	Maximum permissible		
	harmonic current (A)		
Odd	harmonics		
3	2.3		
5	1.14		
7	0.77		
9	0.4		
11 🔶	0.33		
13	0.21		
15≪n≪39	0.15*(15/n)		
Even	harmonics		
2	1.08		
4	0.43		
6	0.30		
8≤n≤40	0.23*(8/n)		

Note: Reference standard of the table above: EN61000-3-2.

Page 33 of 74 Report No.: STR221215001011E

NTEK 北测

3.3.2 TEST PROCEDURE

a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions.

b. The classification of EUT is according to section 5 of EN 61000-3-2. The EUT is classified as follows:

Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.

Class B: Portable tools. Portable tools.; Arc welding equipment which is not professional equipment.

Class C: Lighting equipment.

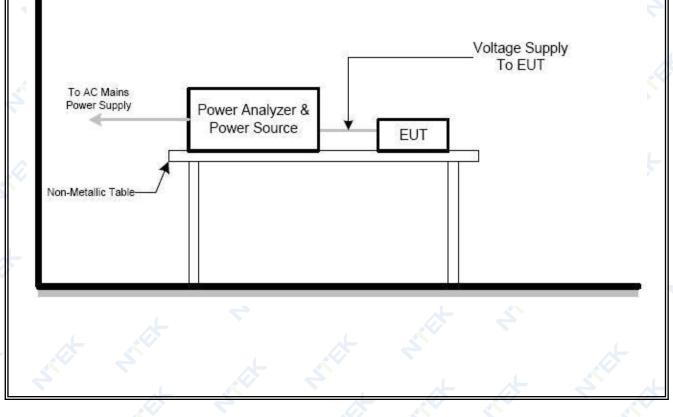
Class D: Equipment having a specified power less than or equal to 600W of the following types: Personal computers and personal computer monitors and television receivers.

c. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

3.3.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.

3.3.4 TEST SETUP



Page 34 of 74 Report No.: STR221215001011E

3.3.5 TEST RESULTS

EUT:	Smart phone	Model Name:	A53 Pro
Temperature:	22 °C	Relative Humidity:	53%
Pressure:	1012hPa	Test duration:	150s
Classification:	Class A	Test Power:	N/A
Test Mode:	N/A		x x

Note: The active input power of the EUT is less than 75 W. No limits apply for equipment with an active input power up to and including 75W.

Page 35 of 74 Report No.: STR221215001011E

NTEK 北测

3.4 VOLTAGE FLUCTUATION AND FLICKERS

3.4.1 LIMITS OF VOLTAGE FLUCTUATION AND FLICKERS

Test items	Limits(EN61000-3-3)	Descriptions
P _{st}	≤1.0, T _p =10min	short-term flicker indicator
P _{lt}	 ≤0.65, T_p=2h 	long-term flicker indicator
d _c ≤3.3%		relative steady-state voltage change
d _{max}	≪4%(or 6% _{Note(1)} , 7% _{Note(2)})	maximum relative voltage change:
d _(t) ≤3.3%, more than 500ms		relative voltage change characteristic

Note:

- 1. 6 % for equipment which is:
 - a. switched manually, or

b. switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption.

2. 7 % for equipment which is

a. attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or b. switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.

3.4.2 TEST PROCEDURE

a. Harmonic Current Test:

Test was performed according to the procedures specified in Sub-clause 6.2 of IEC/EN 61000-3-2 depend on which standard adopted for compliance measurement.

b. Fluctuation and Flickers Test:

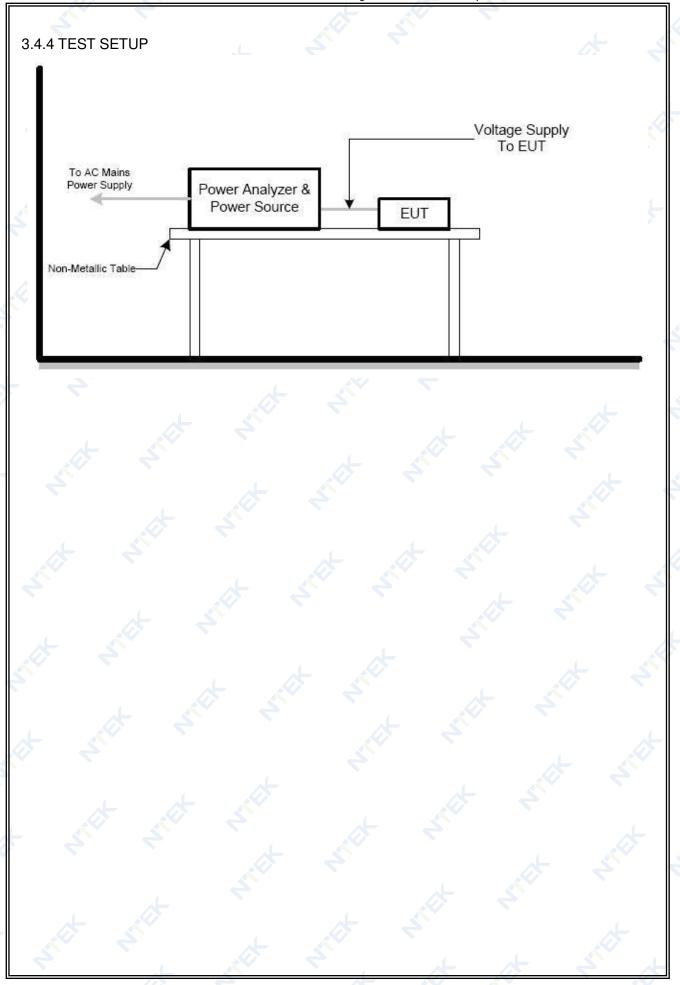
Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in Clause 6.0/4.0 of IEC/EN 61000-3-3 depend on which standard adopted for compliance measurement.

c. All types of harmonic current and/or voltage fluctuation in this report are assessed by direct measurement using flicker-meter.

3.4.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.

Page 36 of 74 Report No.: STR221215001011E



Page 37 of 74 Report No.: STR221215001011E

3.4.5 TEST RESULTS

EUT:	Smart phone		Model Name:	A53 Pro
Temperature:	22.2 ℃		Relative Humidity:	52%
Pressure:	1010 hPa	A CAL	Test Power:	DC 5V from Adapter AC 230V/50Hz
Test Mode:	Mode 1	7	4	+ 5
				\sim \prec

	EUT values	Limit	Result		
Pst	0.028	1.00	PASS		
Plt	0.028	0.65	PASS		
dc [%]	0.000	3.30	PASS		
dmax [%]	0.071	7.00	PASS		
Tmax [s]	0.000	0.50	PASS		



Page 38 of 74 Report No.: STR221215001011E

NTEK 北测[®]

4. EMC IMMUNITY TEST

4.1 GENERAL PERFORMANCE CRITERIA

4.1.1 PERFORMANCE CRITERIA

According to EN 55035 standard, the general performance criteria as following:

	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as
Criterion A	intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not
	specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion B	After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.
Criterion C	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

According to EN 301 489-3 standard, the general performance criteria as following:

Criteria	During the test	After the test							
	Operate as intended	Operate as intended							
	No loss of function	No loss of function							
А	No unintentional responses	No degradation of performance							
		No loss of stored data or user programmable							
		functions							
		Operate as intended							
	May show loss of function	Lost function(s) shall be self-recoverable							
В	No unintentional responses	No degradation of performance No loss of stored data or user programmable							
	No unintentional responses								
		functions							

Page 39 of 74 Report No.: STR221215001011E

Criteria	During the test	After the test
×	Shall operate as intended (see note 1).	Shall operate as intended.
	Shall be no loss of function.	Shall be no degradation of performance
	Shall be no unintentional	(see note 3).
A	transmissions	Shall be no loss of function.
		Shall be no loss of stored data or user
	- Z	programmable functions
	May show loss of function (one or	Functions shall be self-recoverable.
	more).	Shall operate as intended after recovering.
в	May show degradation of performance	Shall be no degradation of performance
D	(see note 2).	(see note 3).
	Shall be no unintentional	Shall be no loss of stored data or user
	transmissions. 🙏 🛛 🔨	programmable functions.
	At an I	Functions shall be recoverable by the
		operator.
c	May be loss of function (one or more)	Shall operate as intended after recovering.
		Shall be no degradation of performance
		(see note 3).

NOTE 1: Operate as intended during the test allows a level of degradation not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended. NOTE 2: Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 3: No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

Page 40 of 74 Report No.: STR221215001011E

NTEK 北测

According to EN 301 489-19 standard, the general performance criteria as following:

If the EUT is of a non specialized nature or the EUT is combined with an ancillary equipment, the test modulation, test arrangements, etc. as required in clause 4 shall apply.

The EUT, for all immunity tests according to the present document, except the spot frequency test of the immunity test with radiated RF electromagnetic fields (see ETSI EN 301 489-1 [1], clause 9.2), shall be assessed for:

- the storage of messages in the memory of the EUT at the start of the test;
- unintentional responses of the EUT during the test;
- the maintenance of the EUT memory assessed at the conclusion of the test;
- the ability to receive and store messages at the conclusion of the test.

For the spot frequency test of the immunity test with radiated RF electromagnetic fields (see ETSI EN 301 489-1 [1], clause 9.2) the EUT shall be assessed by monitoring the accuracy of the call received alert signal.

Performance criteria for Continuous phenomena applied to ROMES and ROGNSS receivers (CR)

For the EUT, excluding spot frequency tests as part of the immunity test with radiated RF electromagnetic fields (see ETSI EN 301 489-1 [1], clause 9.2):

- the general performance criteria set out in clause 6.1;
- during the test no false calls shall occur;

• at the conclusion of the test comprising the series of individual exposures the EUT shall operate as intended with no loss of functions or stored data (messages), as declared by the manufacturer.

For the spot frequency test as part of the immunity test with radiated RF electromagnetic fields (see ETSI EN 301 489-1 [1], clause 9.2) the EUT shall be assessed by monitoring the accuracy of the call received alert signal.

Performance criteria for Transient phenomena applied to ROMES and ROGNSS receivers (TR)

For the EUT:

- the general performance criteria set out in clause 6.1;
- during the test no false calls shall occur;
- at the conclusion of the test comprising the series of individual exposures, the EUT shall operate as intended with no loss of function and/or stored data (messages), as declared by the manufacturer.

Page 41 of 74 Report No.: STR221215001011E

Special conditions for EMC immunity tests Table 2: Special conditions for EMC immunity tests

Reference to clauses in ETSI EN 301 489-1 [1]	Special product-related conditions, additional to or modifying the test conditions in ETSI EN 301 489-1 [1], clause 9
9.1 Test configuration; Test methods and levels for immunity tests	The message memory shall be loaded with recognizable messages. The EUT shall operate in stand-by mode of operation, except for the spot frequency test as part of the immunity test with radiated RF electromagnetic fields (see ETSI EN 301 489-1 [1], clause 9.2) where repetitive calls shall be coupled to the input of the receiver. • for the immunity tests of ancillary equipment, without a separate pass/fail criteria, an EUT coupled to the ancillary equipment shall be used to judge whether the ancillary equipment passes or fails.
9.2.2 Test method; Radio frequency electromagnetic field	Spot frequency test: A spot frequency test shall additionally be performed at:

Page 42 of 74 Report No.: STR221215001011E

PERFORMANCE FOR TT

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR TR

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR CT

The performance criteria A shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an Acknowledgement (ACK) or Not Acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR CR

The performance criteria A shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

According to EN 301 489-52 standard, the general performance criteria as following:

GSM and DCS Performance Criteria Please refer to the standard ETSI EN 301 489-52 V1.2.1 clause 6.1.

CDMA Direct Spread (UTRA and E-UTRA) Performance Criteria Please refer to the standard ETSI EN 301 489-52 V1.2.1 clause 6.2.

4.2 GENERAL PERFORMANCE CRITERIA TEST SETUP

The EUT tested system was configured as the statements of **2.2** Unless otherwise a special operating condition is specified in the follows during the testing.

Page 43 of 74 Report No.: STR221215001011E

4.3 ESD TESTING

4.3.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Required Performance	В
Discharge Voltage:	Air Discharge: 2kV/4kV/8kV
	Contact Discharge: 2kV/4kV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	Air Discharge: min. 20 times at each test point
	Contact Discharge: min. 200 times in total
Discharge Mode:	A/C Discharge
Discharge Period:	1 second minimum

4.3.2 TEST PROCEDURE

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

- a. Indirect application of the discharge:
 - Vertical Coupling Plane (VCP):

At least 10 single discharges (in the most sensitive polarity) shall be applied to the centre of one vertical edge of the coupling plane. The coupling plane, of dimensions 0,5 m \times 0,5 m, is placed parallel to, and positioned at a distance of 0,1 m from, the EUT.

Discharges shall be applied to the coupling plane, with sufficient different positions such that the four faces of the EUT are completely illuminated. One VCP position is considered to illuminate 0.5 m \times 0.5 m area of the EUT surface.

Horizontal Coupling Plane (HCP):

Discharge to the HCP shall be made horizontally to the edge of the HCP.

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the centre point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

The discharge electrode shall be in contact with the edge of the HCP before the discharge switch is operated

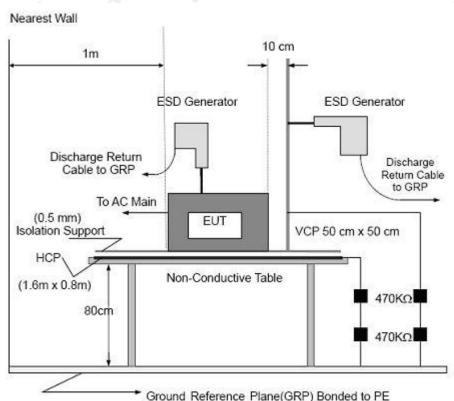
b. Direct application of discharges to the EUT

The test shall be performed with single discharges. On each pre-selected point at least 10 single discharges (in the most sensitive polarity) shall be applied.

For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.

Page 44 of 74 Report No.: STR221215001011E

4.3.3 TEST SETUP



Note:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

FLOOR-STANDING EQUIPMENT

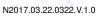
The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

Page 45 of 74 Report No.: STR221215001011E

4.3.4 TEST RESULTS

EUT:	Smart phone	Model Name:	A53 Pro
Temperature:	22 °C	Relative Humidity:	53%
Pressure:	1010 hPa		DC 5V from Adapter AC 230V/50Hz / DC 5V from PC
Test Mode:	Mode 1/2/3/4/5/6/7/8/9/10		

Mode	Contact D	isch	arg	e (Ir	ndire	ect)			
Test level(kV)	Test Point	4	2		4		6	Criterion	Result
Test Location		+	-	+	-	+	-		
1	Front	Ρ	Ρ	Ρ	Ρ				
HCP	Rear	Ρ	Ρ	Ρ	Ρ				at at
ПСР	Left	Ρ	Ρ	Ρ	Ρ			×	
	Right	Right P		Ρ	Ρ	X		Б	Complian
1	Front	Ρ	Ρ	Ρ	P				Complies
VCP	Rear	Ρ	Ρ	Ρ	Ρ				A A
VCP	Left	Ρ	Ρ	Ρ	Ρ				
	Right	Ρ	Ρ	Ρ	Ρ			SV S	

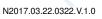


Page 46 of 74 Report No.: STR221215001011E

TEST RESULT

	Mode	5/6/7/8/9/10	
--	------	--------------	--

Mode		Air Discharge								Cor	nta	ct [Dis	cha	argo	Э	BT / WIFI / GSM /			
Test level(kV)	2	2	4	-	ξ	3	1	15		2		4		6		3	WCDMA / LTE	GPS Obser	Crite rion	Result
Test Location	+	-	+	-	+	-	+	-	+	-	+	-	+	-	+	-	Observati on	vation		
A1	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ														
A2	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ									7					
A3	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ				V								t		4
A4	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ										Ļ	TT,TR	TR	В	Complies
A5	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ					ł						11,10	IN	D	Complies
A6	Ρ	Ρ	Ρ	Ρ	Ρ	Р														X
A7	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ												2		
A8 🔨	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ											5			



Page 47 of 74 Report No.: STR221215001011E

Mode 1/2/3/4

/3/4																		6	
Mode		A	ir I	Dis	cha	arge	Э		(Cor	nta	ct D	Diso	cha	irge	Э			
Test level(kV)	2	2	4	ŀ	8	3	1	5	2	2	2	1	6	5	8	3	Crite rion	Result	
Test Location	+	-	+	-	+	-	+	-	+	-	+	-	+	-	+	-			
A1	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ											Y	5	
A2	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ										\mathbf{k}			
A3	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ	2												
A4	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ												Complian	
A5	Ρ	Р	Ρ	Ρ	Ρ	Ρ											Б	Complies	
A6	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ													
A7	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ												At 1	
A8	Ρ	Ρ	Ρ	Ρ	Ρ	Ρ										>		<u> </u>	
	Mode Test level(kV) Test Location A1 A2 A3 A3 A4 A5 A6 A7	ModeTest level(kV)Test LocationA1A2A2A3PA4A5PA6PA7P	ModeATest level(kV)2Test Location+A1PA2PA3PA4PA5PA6PA7P	Mode \rightarrow ir ifTest level(kV)24Test Location+-+A1PPPA2PPPA3PPPA4PPPA5PPPA6PPPA7PPP	Mode \rightarrow in DiscriptionTest level(kV)24Test Location+-+A1PPPA2PPPA3PPPA4PPPA5PPPA7PPP	Mode $Air DischarTestlevel(kV)248TestLocation+-+-A1PPPPA2PPPPA3PPPPA4PPPPA5PPPPA6PPPPA7PPPP$	ModeAir DischargeTest level(kV)248Test Location+-+-A1PPPPPA2PPPPPA3PPPPPA4PPPPPA5PPPPPA7PPPPP	Mode $Air DischargeTestlevel(kV)2481TestLocation+-+-+-A1PPPPPPPA2PPPPPPPA3PPPPPPPA5PPPPPPPA6PPPPPPPA7PPPPPPP$	ModeAir DischargeTest level(kV)24815Test Location+-+-+-A1PPPPPPPA2PPPPPP0A3PPPPPP0A5PPPPP00A6PPPPP00A7PPPPP00	ModeAir Discharge 0 Test level(kV)248152Test Location+-+-+-+A1PPPPPP+-+A2PPPPPPP11A3PPPPPP11A4PPPPPP11A5PPPPPP11A6PPPPPP11A7PPPPPP11	Mode $Air DischargeCorTestlevel(kV)248152TestLocation+-+-+-+-A1PPPPPP111A2PPPPPP111A3PPPPPP111A4PPPPPP111A5PPPPP111A6PPPPP111A7PPPPP111$	ModeAir DischargeContactTest level(kV)2481524Test Location+-+-+-+-A1PPPPPP1111A2PPPPPP1111A3PPPPPP1111A4PPPPPP1111A5PPPPPP1111A6PPPPPP1111A7PPPPPP1111	ModeAir DischargeContact IITest level(kV)2481524Test Location+-+-+-+-A1PPPPPIIIIIA2PPPPPIIIIIIA3PPPPPIIIIIIA4PPPPPIIIIIIA5PPPPPIIIIIIA7PPPPPIIIIII	ModeAir DischargeContact DiscTest level(kV)24815246Test Location+-+-+-+-+-+A1PPPPPP+-+-+-A2PPPPPPIIIIIIIIIIIA3PPPPPPII	Mode Air Discharge Contact Discharge Test level(kV) 2 4 8 15 2 4 6 Test Location + - + <t< td=""><td>ModeAir DischargeContact DischargeTest level(kV)248152468Test Location+-+-+-+-+-+-A1PPPPPPII</td><td>Mode Air Discharge Contact Discharge Test 2 4 8 15 2 4 8 Test + -</td><td>$\begin{array}{ c c c c c c c c c c c c c c c c c c c$</td><td>$\begin{array}{ c c c c c c c c c c c c c c c c c c c$</td></t<>	ModeAir DischargeContact DischargeTest level(kV)248152468Test Location+-+-+-+-+-+-A1PPPPPPII	Mode Air Discharge Contact Discharge Test 2 4 8 15 2 4 8 Test + -	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$

Note:

1) +/- denotes the Positive/Negative polarity of the output voltage.

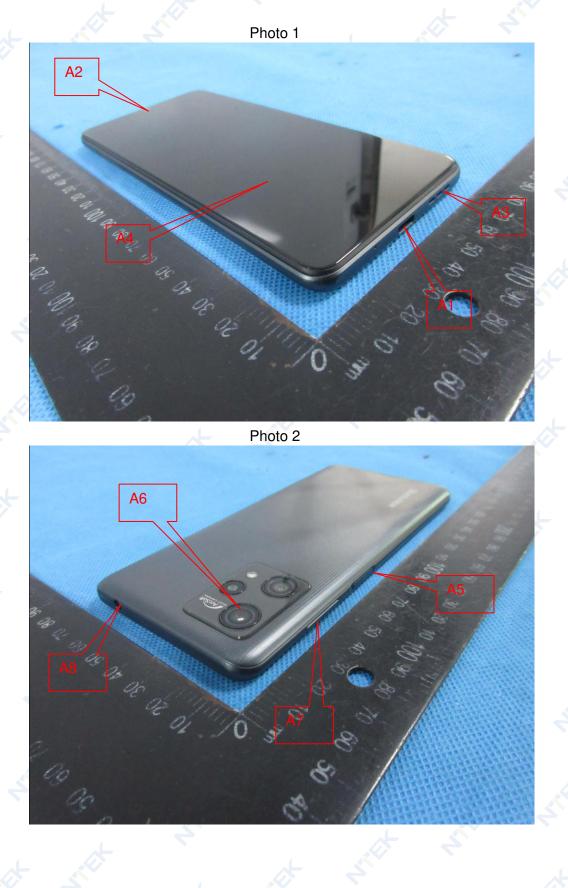
2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.

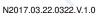
3) There was not any unintentional transmission in standby mode.



Page 48 of 74 Report No.: STR221215001011E

4.3.5 PHOTO(S) SHOWN THE LOCATION(S) OF ESD EVALUATED





Page 49 of 74 Report No.: STR221215001011E

4.4 RS TESTING

4.4.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-3						
Required Performance	A						
Frequency Range:	According to EN 301 489-1:						
	80 MHz - 6000 MHz ;						
	According to EN 55035:						
	80 MHz to 1000 MHz						
	1800 MHz						
	2600 MHz 🔶						
	3500 MHz						
	5000 MHz						
Field Strength:	3 V/m						
Modulation:	1kHz Sine Wave, 80%, AM Modulation						
Frequency Step:	1 % of fundamental						
Polarity of Antenna:	Horizontal and Vertical						
Test Distance:	3 m 🗡 🖉 🍝						
Antenna Height:	1.5 m						
Dwell Time:	at least 3 seconds						

4.4.2 TEST PROCEDURE

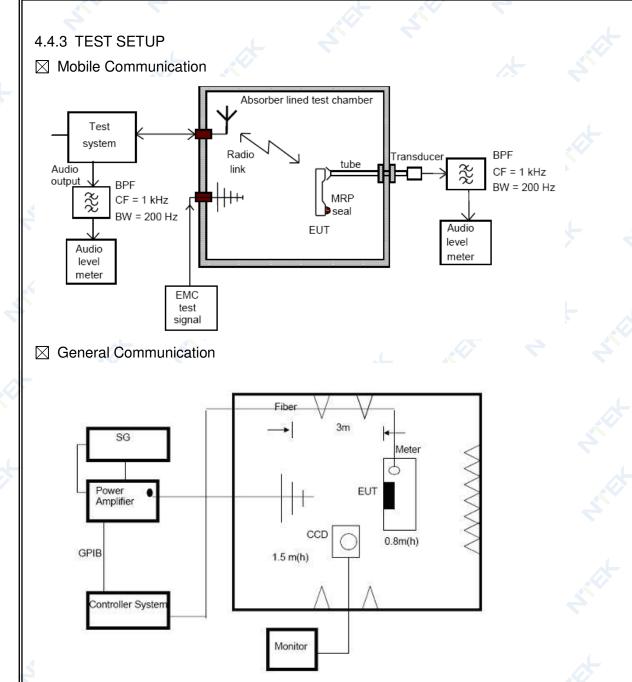
The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber.

The testing distance from antenna to the EUT was 3 meters.

The other condition as following manner:

- a. The field strength level was 3V/m.
- b. The frequency range is swept from 80 MHz to 6000 MHz, 1800 MHz, 2600 MHz, 3500 MHz, 5000 MHz with the signal 80% amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed 1.5 x 10⁻³ decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. Sweep Frequency 900 MHz, with the Duty Cycle:1/8 and Modulation: Pulse 217 Hz(if applicable)
- d. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.
- f. For the actual test configuration, please refer to the related Item -EUT Test Photos.

Page 50 of 74 Report No.: STR221215001011E



Note:

For the actual test configuration, please refer to the related Item -EUT Test Photos.

TABLE-TOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

Page 51 of 74 Report No.: STR221215001011E

4.4.4 TEST RESULTS

EUT:	Smart phone	Model Name:	A53 Pro
Temperature:	23 °C	Relative Humidity:	57%
Pressure:	1010 hPa		DC 5V from Adapter AC 230V/50Hz / DC 5V from PC
Test Mode:	Mode 1/2/3/4/5/6/7/8/9/10		

TEST RESULT

LTE FDD B1 / B3 / B7 / B8 / B20 / B28 / B40 Data Link

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Observation	Results
~ ~			Front		P
80~1000	H/V	3 V/m (rms) AM Modulated	Rear	CT CD	
1000-6000			Left	CT,CR	
		1000Hz, 80%	Right	· · · · ·	

Note:

The exclusion band has not been tested in 80MHz~6GHz.
 For channelized equipment the exclusion band shall be calculated by using the following formulae:

For the lower edge for the exclusion band:

EXband(lower) = BandRX(lower) - nChWRX

and for the upper edge of the exclusion band:

EXband(upper) = BandRX(upper) + nChWRX

- Where n = number of channel widths required for exclusion band.
- 2. In the data transfer mode, the performance criteria shall be that the throughput shall be \geq 95 % of the maximum throughput of the reference measurement channel

Page 52 of 74 Report No.: STR221215001011E

GSM 900 / 1800 / WCDMA 2100 / 900 Uplink and Downlink											
Frequency Range	RF Field	R.F.	Azimuth	Observation	Perform.	Results					
(MHz)	Position	Field Strength	Azimum	Observation	Criteria	nesuits					
Str.		3 V/m (rms) AM Modulated 1000Hz, 80%	Front								
80~1000	н/у		Rear	CT,CR		P					
1000-6000			Left	CI,CR	A	Р					
A S		1000112, 0078	Right								

Note:

1. The exclusion band has not been tested in 80MHz~6GHz.

For channelized equipment the exclusion band shall be calculated by using the following formulae:

For the lower edge for the exclusion band:

EXband(lower) = BandRX(lower) - nChWRX

and for the upper edge of the exclusion band:

EXband(upper) = BandRX(upper) + nChWRX

Where n = number of channel widths required for exclusion band.

2: "A" stand for: the uplink/downlink speech output level shall be at least 35 dB less than the previously recorded reference levels, when measured through an audio band pass filter of width 200 Hz, centred on 1 kHz (audio breakthrough check). The RXQUAL of the downlink is not exceeding the value of three, measured during each individual exposure in the test sequence. Or During and after the test, the apparatus continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level.

Page 53 of 74 Report No.: STR221215001011E

GPRS / EGPRS / HSDPA / HSUPA Uplink and Downlink

							_
Frequency	RF Field	R.F.	Azimuth	Observation	Perform.	Results	
Range (MHz)	Position	Field Strength	/\2.1110(11		Criteria	ricouito	
5		2 M/m (rma)	Front		A _	P	
80~1000	H/V	3 V/m (rms) AM Modulated	Rear	CT,CR			
1000-6000		1000Hz, 80%	Left				
		1000112, 00 /6	Right				

Note:

1. The exclusion band has not been tested in 80MHz~6GHz.

For channelized equipment the exclusion band shall be calculated by using the following formulae:

For the lower edge for the exclusion band:

EXband(lower) = BandRX(lower) - nChWRX

and for the upper edge of the exclusion band:

EXband(upper) = BandRX(upper) + nChWRX

Where n = number of channel widths required for exclusion band.

2. During the test, the Maximum Bit Error Ratio was less than 1×10⁻³.

3. During the test, the Maximum Block Error Ratio was less than 1×10⁻².

BT / WIFI link

Frequency	RF Field	Field R.F. Azimuth		Observation	Perform.	Results		
Range (MHz)	Position	Field Strength	Azimum	Observation	Criteria	nesulis		
Str.			Front	<u> </u>	A	P		
80~1000	H/V	3 V/m (rms) AM Modulated 1000Hz, 80%	Rear	OT OD				
1000-6000			Left	CT,CR				
なな		1000112, 00 /8	Right	t i				

Note:

- 1. The exclusion band has not been tested in 80MHz~6GHz.
- The exclusion band for immunity testing of equipment operating in the 2,4 GHz band shall be: lower limit of exclusion band = lowest allocated band edge frequency -120 MHz, i.e. 2 280 MHz; • upper limit of exclusion band = highest allocated band edge frequency +120 MHz, i.e. 2 603,5MHz.
- 2. "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

Page 54 of 74 Report No.: STR221215001011E

le Link	X	. 4		6	5 2
RF Field	R.F.	Azimuth	Observation	Perform.	Results
Position	Field Strength	Azimum	Observation	Criteria	nesuits
		Front			
		Rear			P
		Left			
		Right	4		
		Front		X	
	3 V/m (rms)	Bear			
H/V	Unmodulated		CR	A	Р
1	200Hz, 100%	Left	'		
At S		Right			
	RF Field Position H / V	RF FieldR.F.PositionField StrengthAM Modulated3 V/m (rms)AM Modulated1000Hz, 80%AM V/m (rms)1000Hz, 80%	RF Field PositionR.F. Field StrengthAzimuthPositionField StrengthFront3 V/m (rms) AM Modulated 1000Hz, 80%RearLeftLeft3 V/m (rms) Unmodulated 200Hz, 100%Front	RF Field PositionR.F. Field StrengthAzimuthObservationPositionField StrengthFrontImage: StrengthImage: Strength3 V/m (rms)AM Modulated 1000Hz, 80%FrontImage: StrengthImage: StrengthH / VAM Modulated 1000Hz, 80%Image: StrengthImage: StrengthImage: StrengthH / VStrengthFrontImage: StrengthImage: StrengthH / VStrengthImage: StrengthImage: StrengthImage: StrengthH / VUnmodulated 200Hz, 100%Image: StrengthImage: StrengthImage: Strength	RF Field PositionR.F. Field StrengthAzimuthObservationPerform. CriteriaH / VField StrengthFrontRearA3 V/m (rms)RearLeftA1000Hz, 80%RightFront3 V/m (rms)RearCRA1000Hz, 80%FrontRear3 V/m (rms)RearCRA4 M Modulated 1000Hz, 80%FrontCRA1000Hz, 80%ErontCRA

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

REC / TF Playing /Data Transmission / FM Mode

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Perform. Criteria	Results	
80~1000 1000~6000		A.	Front		×	
1800	H/V	3 V/m (rms) AM Modulated	Rear		Р	2
2600		1000Hz, 80%	Left		•	
5000			Right		* *	

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions. There was not any unintentional transmission in standby mode.

Page 55 of 74 Report No.: STR221215001011E

4.5 EFT/BURST TESTING

4.5.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-4					
Required Performance	B					
Test Voltage:	Power Line: 1 kV					
	DC/Signal/ wired network Line: 0.5 KV					
Polarity:	Positive & Negative					
Impulse Frequency:	For xDSL wired network ports: 100 kHz					
	For DC/AC ports: 5 kHz					
Impulse Wave shape :	5/50 ns 🧳					
Burst Duration:	15 ms					
Burst Period:	300 ms					
Test Duration:	Not less than 1 min.					

4.5.2 TEST PROCEDURE

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min.

The other condition as following manner:

- a. The length of power cord between the coupling device and the EUT should not exceed 1 meter.
- b. Both positive and negative polarity discharges were applied.
- c. The duration time of each test sequential was 1 minute
- d. For the actual test configuration, please refer to the related Item -EUT Test Photos.

Page 56 of 74 Report No.: STR221215001011E

4.5.3 TEST SETUP Nearest Wall >0.5m L ≤ 0.5m EFT/Burst Generator To AC Mains Supply Coupling/ EUT Decoupling Protective GND letwork Devic 10cm# Ground Reference Plane (GRP) 80 cm To Earth Ground Reference Plane (GRP) Bonded to Earth L1=L2=0.5m+/- 0.0.m apacitive AC Mains Supply Coupling 1.2 1.1 D EUT 10 cm 1 10cm Ground Reference Plane To Earth GND Connection According to the MFR's Specification (GRP) Bonded to Earth Isolation Support (10 cm) EFT/Burst Generator Coupling/ Decoupling Network Device

Note:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table (0.8m high) standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure. FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-4 and its cables, were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.

Page 57 of 74 Report No.: STR221215001011E

4.5.4 TEST RESULTS

EUT:	Smart phone	Model Name:	A53 Pro
Temperature:	22 °C	Relative Humidity:	53%
Pressure:	1010 hPa	LAST POWAR	DC 5V from Adapter AC 230V/50Hz
Test Mode:	Mode 1/2/4/5/6/7/8/9/10		

TEST RESULT Mode 5/6/7/8/9/10

	10							
		Test level (kV)						
Coupling Line	0	.5	1		2		4	ł
	+	-	+	-	+	-	+	-

					Tes	t lev	el (k	V)			BT / WIFI /	GPS		
	Cou	pling Line	0	.5	-			GSM / WCDMA / LTE	Observ	Criteri on	Result			
				-	+	-	+	-	+	-	Observation	ation		
		L	Ρ	Ρ	Ρ	Ρ	V					Ŷ		Complies
		N	Ρ	Р	Ρ	Ρ					Ret &			Complies
		PE						Ŷ						
	AC line	L+N	P P P P			1	Complies							
		L+PE									TT,TR	TR	В	
		N+PE	V								* ~			
	V	L+N+PE												
	D	C Line		ł		4								
	Się	nal Line	Ś								<u></u>			
			K								A -			



Page 58 of 74 Report No.: STR221215001011E

Mode 1/2/4	1		Ļ		~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~						the second
				Te	est lev	/el (k	V)				
Coupli	ng Line	0	.5		1		2	4	4	Criterion	Result
		+	-	+	-	+	-	+	-		
	Ц.	Р	Р	Р	Р					<u>ل</u>	Complies
*	Ň	Р	Р	Р	Р			5			Complies
	PE				Y		Ś		γ		6
AC line	L+N	Ρ	Ρ	P	Р					1 /	Complies
	L+PE									Б	
	N+PE								ľ		
	L+N+PE					7.					-
DC	Line			2							
Signa	al Line									7	~

Note:

- 1)There was not any unintentional transmission in standby mode
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.
- 3) There was not any unintentional transmission in standby mode.

Page 59 of 74 Report No.: STR221215001011E

4.6 SURGE TESTING

4.6.1 TEST SPECIFICATION

IEC/EN 61000-4-5
B
Combination Wave
1.2 / 50 us Open Circuit Voltage
8 / 20 us Short Circuit Current
Power Line:0.5 kV, 1 kV, 2 kV
L-N, L-PE, N-PE
2 ohm between networks
12 ohm between network and ground
Positive / Negative
0 / 90 / 180 / 270
1 time / min. (maximum)
5 positive and 5 negative at selected points

4.6.2 TEST PROCEDURE

- a. For EUT power supply:
- The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).
- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT: The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- c. For test applied to unshielded symmetrically operated interconnection /telecommunication lines of EUT:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

d. For the actual test configuration, please refer to the related Item -EUT Test Photos.

Page 60 of 74 Report No.: STR221215001011E

4.6.3 TEST SETUP

Page 61 of 74 Report No.: STR221215001011E

4.6.4 TEST RESULTS

EUT:	Smart phone	Model Name:	A53 Pro
Temperature:	22 ℃	Relative Humidity:	53%
Pressure:	1010 hPa	LOCT DOWOR	DC 5V from Adapter AC 230V/50Hz
Test Mode:	Mode 1/2/4/5/6/7/8/9/10	4	\mathbf{x}

TEST RESULT

Mode 5/6/7/8/9/10

	mode	3/0/1/0											4		
						Te	est le	eve	l			BT / WIFI / GSM /			
	Coupling Line	_ine	0.5kV 1kV 2kV 4		4k	٢V	WCDMA	GPS Observati	Criterion	Result					
		1 0		+	-	+	-	+	-	+	-	/ LTE Observati on	on		
			0°	Р	Ρ	Ρ	Ρ	•						1	4
		L-N	90°	Ρ	Ρ	Ρ	Ρ				Ĩ				Complies
		E-IN	180°	Р	Ρ	Ρ	Ρ				1				Complies
			270°	Ρ	Ρ	Ρ	Ρ						×	X .	
			1.									F K		× 5	
	AC	L-PE										TT,TR	TR	В	1 th
	line			L						V		,		U	
		4				ν							X	r	
			1								L		Str.		
		N-PE					L					~			
			L											- 4	
	. [_												<u> </u>		
		DC Line	e												
010	S	ignal Li	ne			F						5			

Page 62 of 74 Report No.: STR221215001011E

						Test	level					
Co	Coupling Line		0.5	0.5 kV		1 kV		2 kV		٨V	Criterion	Result
			+	-	+	-	+	-	+	-		
	4	0°	Р	Р	Р	Р	7					み む
	L-N	90°	Ρ	Р	Р	Р					- 3	Complies
N T		180°	Ρ	Р	Ρ	Р			ľ			Complies
		270°	Р	Р	Р	Ρ	l					
	Ł			r						く	-	1
AC line	L-PE	7									В	
7												
		×										· ×
	+								4	Ļ,	5	S ^V
	N-PE										*	
				*		5						1
		*	5									
×	DC Line											5
S	ignal Line						-	1			2	

Note:

- 1) There was not any unintentional transmission in standby mode
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.
- 3) There was not any unintentional transmission in standby mode.

Page 63 of 74 Report No.: STR221215001011E

4.7 INJECTION CURRENT TESTING

4.7.1 TEST SPECIFICATION

IEC/EN 61000-4-6
A
0.15 MHz - 80 MHz
3 Vr.m.s.
1kHz Sine Wave, 80%, AM Modulation
1 % of fundamental
at least 3 seconds

4.7.2 TEST PROCEDURE

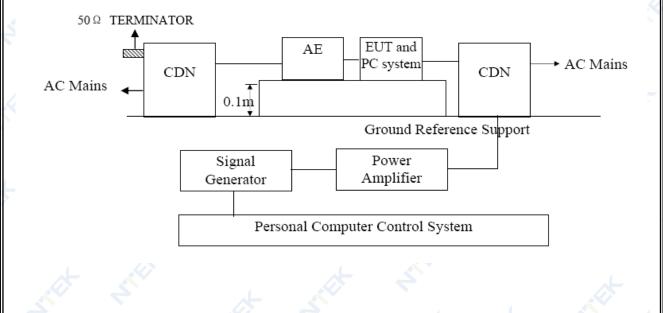
The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min.

The other condition as following manner:

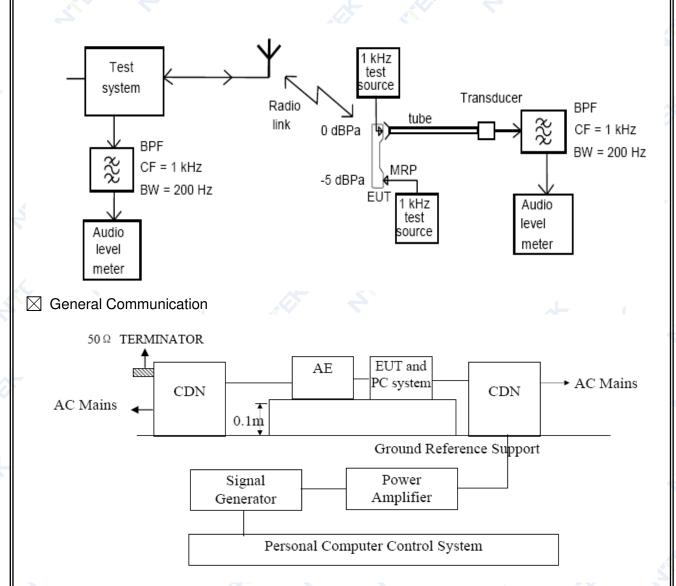
- a. The field strength level was 3V.
- b. The frequency range is swept from 150 KHz to 80 MHz, with the signal 80% amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed 1.5 x 10⁻³ decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d. For the actual test configuration, please refer to the related Item -EUT Test Photos.

4.7.3 TEST SETUP

Mobile Communication



Page 64 of 74 Report No.: STR221215001011E



For the actual test configuration, please refer to the related Item –EUT Test Photos. NOTE:

FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

Page 65 of 74 Report No.: STR221215001011E

4.7.4 TEST RESULTS

EUT:	Smart phone	Model Name:	A53 Pro
Temperature:	22℃	Relative Humidity:	53%
Pressure:	1010 hPa	Test Power:	DC 5V from Adapter AC 230V/50Hz
Test Mode:	Mode1/2/4/5/6/7/8/9/10/11		

TEST RESULT LTE FDD B1 / B3 / B7 / B8 / B20 / B28 / B40Link

Test Ports (Mode)	Freq. Range (MHz)	Field Strength	Observation	Results
Input / Output AC. Power Port	0.1580	3V(rms)	CT, CR	Р
Input / Output DC. Power Port	0.15 80	AM Modulated 1000Hz, 80%	N/A	N/A
Signal Line	0.15 80		N/A	N/A

Note: In the data transfer mode, the performance criteria shall be that the throughput shall be \geq 95 % of the maximum throughput of the reference measurement channel

GSM 900 / 1800 / WCDMA 2100 / 900 Uplink and Downlink

Test Ports (Mode)	Freq. Range (MHz)	Field Strength	Observation	Perform. Criteria	Results
Input / Output AC. Power Port	0.1580	3V(rms)	CT, CR	≁	Р
Input / Output DC. Power Port	0.15 80	AM Modulated 1000Hz, 80%	N/A	N/A	N/A
Signal Line	0.15 80		N/A	N/A 🏑	N/A

EUT is used for this calibration, the output of the audio source was adjusted to achieve a reference Level equivalent to a SPL of –5 dB Pa at 1 kHz at the Mouth Reference Point (MRP), the reading of the audio level meter, which was connected to the output of the communication tester, was recorded as a reference level. During the test, the uplink speech output level was monitored, it was confirmed to be at least 35 dB less than the previously- recorded reference level.



Page 66 of 74 Report No.: STR221215001011E

GPRS / EGPRS / HS	GPRS / EGPRS / HSDPA / HSUPA Uplink and Downlink									
Test Ports	Freq. Range	Field Strength	Observation	Perform.	Results					
(Mode)	(MHz)	Field Strength	Observation	Criteria	Results					
Input / Output	0.15 00									
AC. Power Port	0.1580	3V(rms)	CT, CR	Α	P					
Input / Output	0.15 80	AM Modulated	N/A	N/A	N/A					
DC. Power Port	0.15 80	1000Hz, 80%	N/A	IN/A	N/A					
Signal Line	0.15 80	L L	N/A	N/A	N/A	F				

Note: During the test, the Maximum Bit Error Ratio was less than 1×10^{-3} . During the test, the Maximum Block Error Ratio was less than 1×10^{-2} .

BT / WIFI link

Test Ports (Mode)Freq. Range (MHz)Field StrengthObservationPerform. CriteriaInput / Output AC. Power Port0.15803V(rms)CT, CRAInput / Output 0.15 800.1580MM ModulatedN/A			
AC. Power Port 0.15 80 3V(rms) AM Modulated N/A	Eleid Strength Observation Besuits		
Input / Output 0.15 80 AM Modulated N/A		0.1580	
DC. Power Port 1000Hz, 80%	AM Modulated N/A N/A N/A	0.15 80	Input / Output DC. Power Port
Signal Line 0.15 80 N/A N/A		0.15 80	Signal Line

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

GPS Receiver Mode Link

	Test Ports (Mode)	Freq. Range (MHz)	Field Strength	Perform. Criteria	Results
	Input / Output AC. Power Port	0.15 80	3V(rms)	A A	Р
at 1	Input / Output DC. Power Port	0.15 80	AM Modulated 1000Hz, 80%	N/A	N/A
	Signal Line	0.15 80		N/A	N/A

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

Page 67 of 74 Report No.: STR221215001011E

REC / TF Playing / FM Mode

Test Ports (Mode)	Freq. Range (MHz)	Field Strength	Perform. Criteria	Results	
Input / Output AC. Power Port	0.1580	3V(rms)	A	P	
Input / Output DC. Power Port	0.15 80	AM Modulated 1000Hz, 80%	N/A	N/A	
Signal Line	0.15 80		N/A	N/A	*

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

Note:

- 1)There was not any unintentional transmission in standby mode
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.
- 3) There was not any unintentional transmission in standby mode.

4.8 VOLTAGE INTERRUPTION/DIPS TESTING

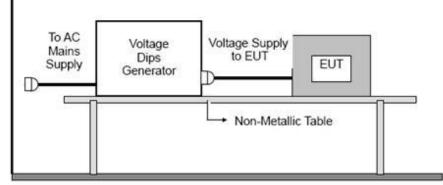
4.8.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-11
Required Performance	100% reduction, 0.5 Cycle
	100% reduction, 1.0 Cycle
	30% reduction, 25 Cycles 🧹 💦 🔶
	30% reduction, 0.5 Cycle
Voltage Interruptions:	100% reduction, 250 Cycles
Test Duration Time:	Minimum three test events in sequence
Interval between Event:	Minimum ten seconds
Phase Angle:	0°/45°/90°/135°/180°/225°/270°/315°/360°
Test Cycle:	3 times

4.8.2 TEST PROCEDURE

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

4.8.3 TEST SETUP



For the actual test configuration, please refer to the related Item -EUT Test Photos.

Page 69 of 74 Report No.: STR221215001011E

4.8.4 TEST RESULTS

EUT:	Smart phone	Model Name:	A53 Pro
Temperature:	22℃	Relative Humidity:	53%
Pressure:	1010 hPa	Test Power:	DC 5V from Adapter AC 230V/50Hz
Test Mode:	Mode 1/2/4/5/6/7/8/9/10	1	+

TEST RESULT

Mode 5/6/7/8/9/10

			4		
Voltage Reduction	Duration (ms)	BT / WIFI / GSM / WCDMA / LTE Observation	GPS Observation	Perform Criteria	Results
Voltage dip: 0%	10	TT, TR	TR	в	Р
Voltage dip: 0%	20	TT, TR	TR	В	Р
Voltage dip: 70%	10	TT, TR	TR	С	Р
Voltage dip: 70%	500	TT, TR	TR	С	Р
Voltage interruptions: 0%	5000	TT, TR	TR	СС	Р

Mode 1/2/4

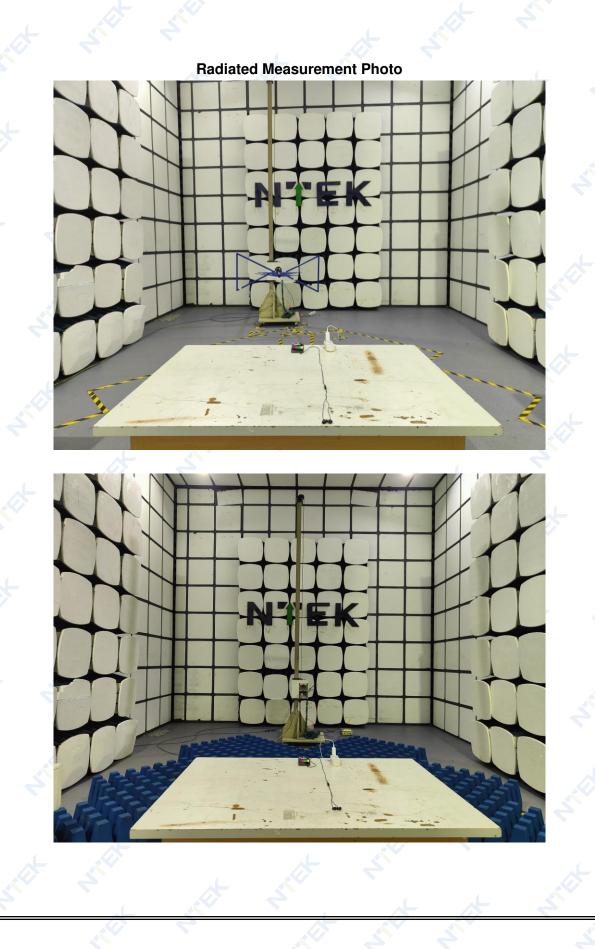
Voltage Reduction	Duration (ms)	Perform Criteria	Results
Voltage dip: 0%	10	В	P
Voltage dip: 0%	20	в	Р
Voltage dip: 70%	10	С	Р
Voltage dip: 70%	500	С	Р
Voltage interruptions: 0%	5000	С	P V

Note:

- 1) There was not any unintentional transmission in standby mode
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.
- 3) There was not any unintentional transmission in standby mode.

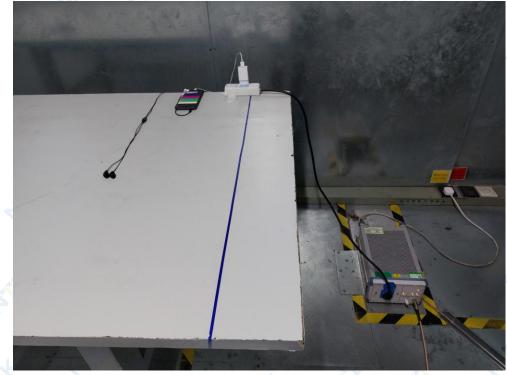
Page 70 of 74 Report No.: STR221215001011E

5. EUT TEST PHOTO



Page 71 of 74 Report No.: STR221215001011E

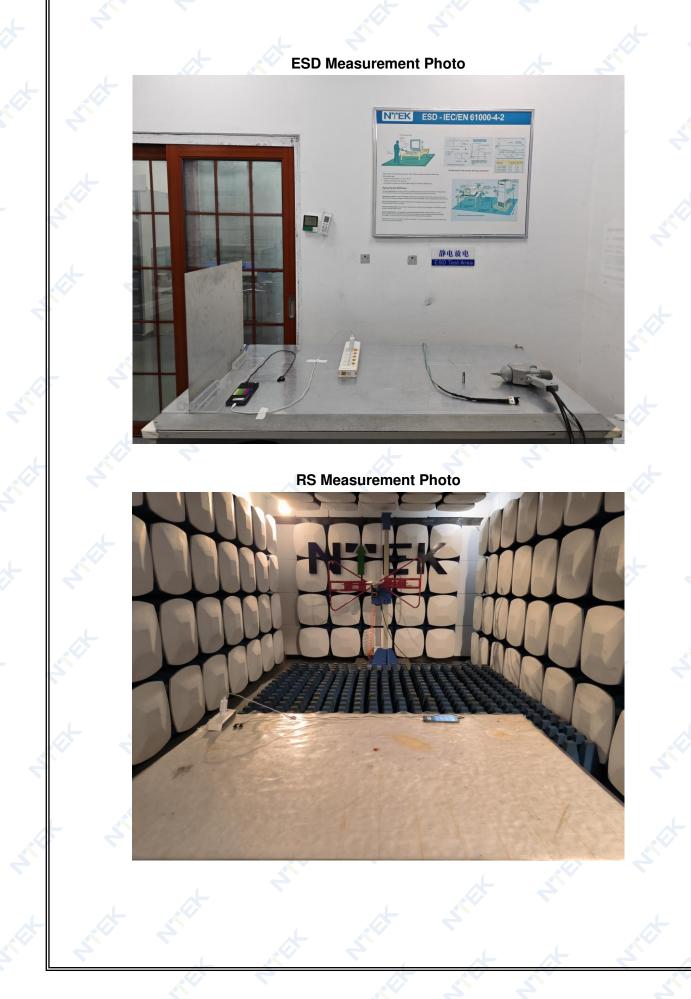




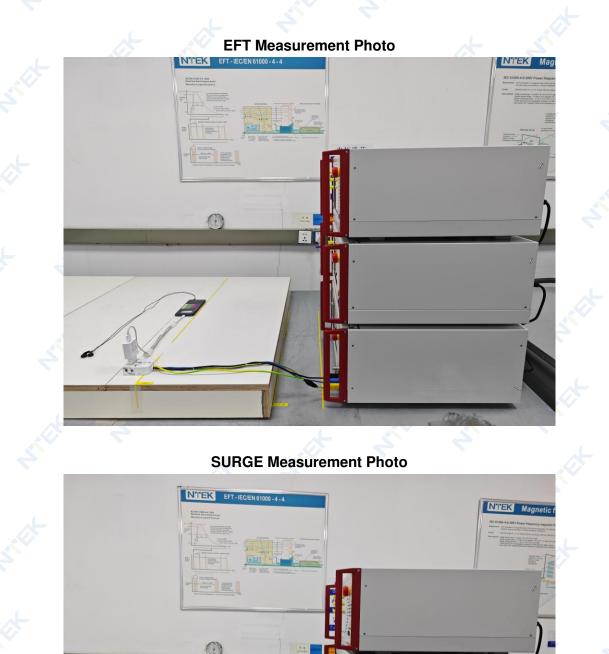
Flick Measurement Photo



Page 72 of 74 Report No.: STR221215001011E



Page 73 of 74 Report No.: STR221215001011E



1. X

N2017.03.22.0322.V.1.0

Page 74 of 74 Report No.: STR221215001011E



END OF REPORT

